



VIAS EM Capabilities – General Overview

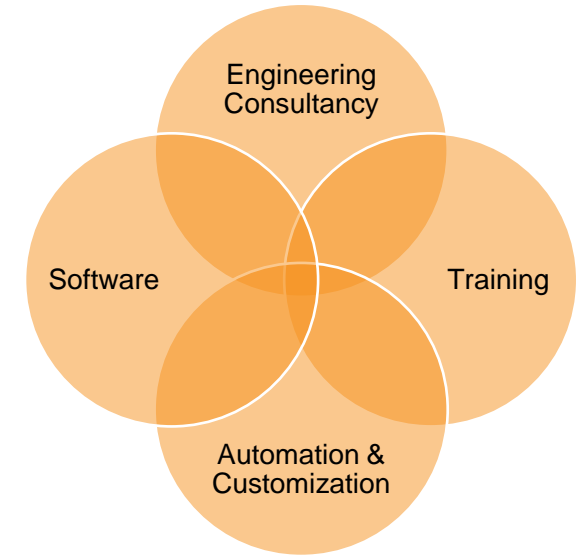
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Who We Are

- Multiple Industry Experience – Hi-Tech, CPG, Oil & Gas, Petrochemical & Process, Nuclear, Aerospace, Medical Devices, Machinery & Equipment, Manufacturing and Automotive
- Global Presence: USA, CANADA..
- Team consists of +50 employees with 7 PhD's and 7 MSc/MTech's in Design, Manufacturing, Structural Mechanics, Fluid Mechanics, Electromagnetics, Optimization & Reliability, Data Analytics, System and Hardware Architecture
- Dassault Systèmes Platinum Partner
- Provide Engineering and PLM Consultancy, Training, Software Sales and Support, Automation and Customization



What is EM Simulation?

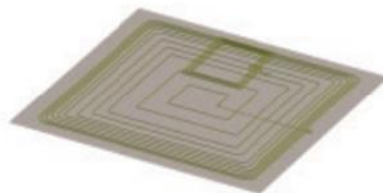
- ▶ EM simulation deals with all kinds of electromagnetic phenomena
- ▶ We can categorize EM simulation by frequency or application
- ▶ Frequency: DC (static) to AC (kHz, MHz, GHz) to visible light (THz)



Touchscreen



Transformer



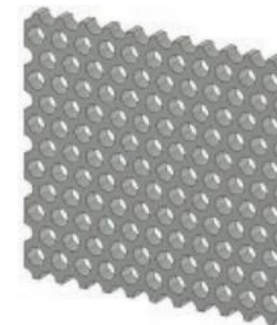
Wireless charging



RFID

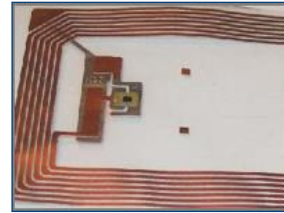
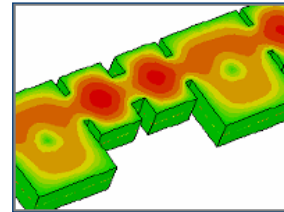
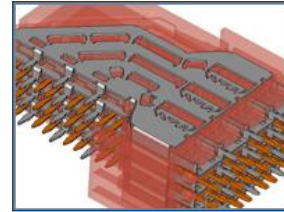
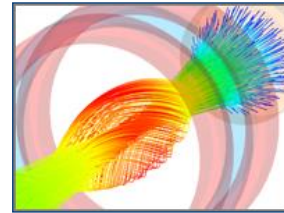
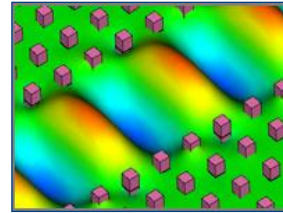
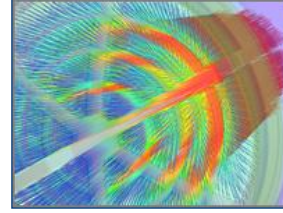
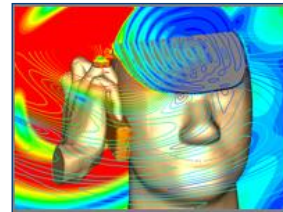
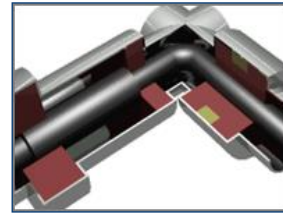
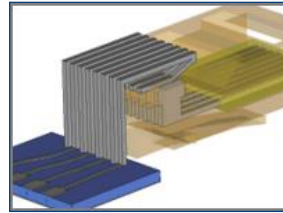
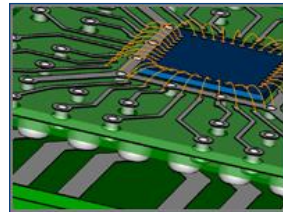
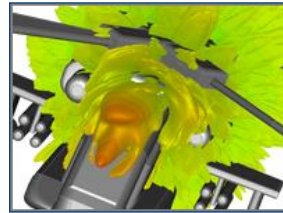
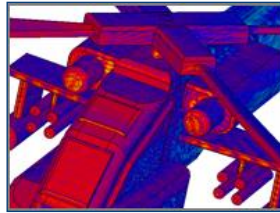
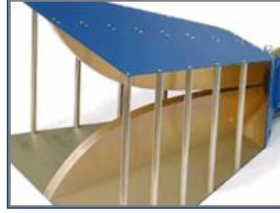
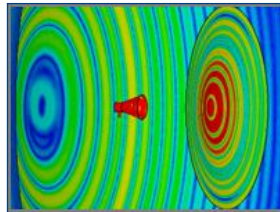
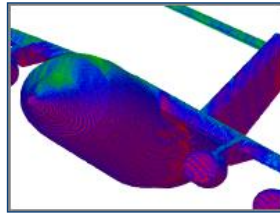
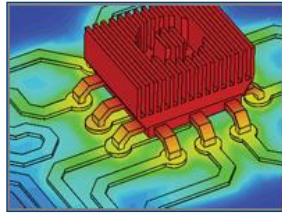
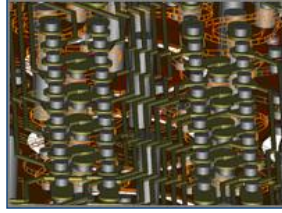
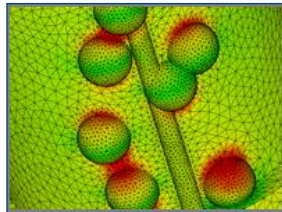
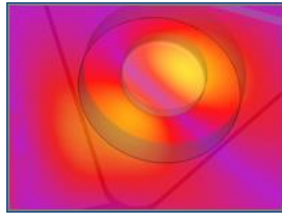
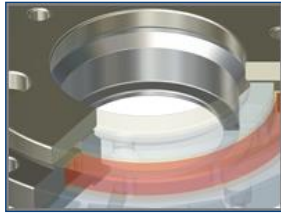
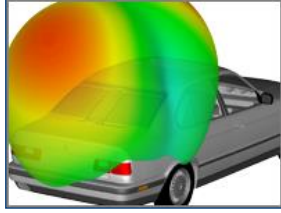
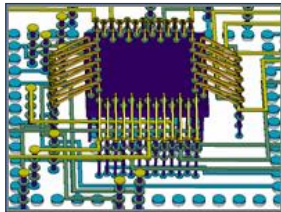
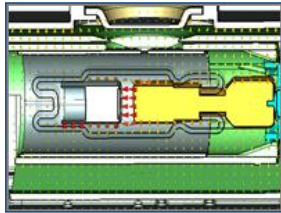


Mobile



Photonics





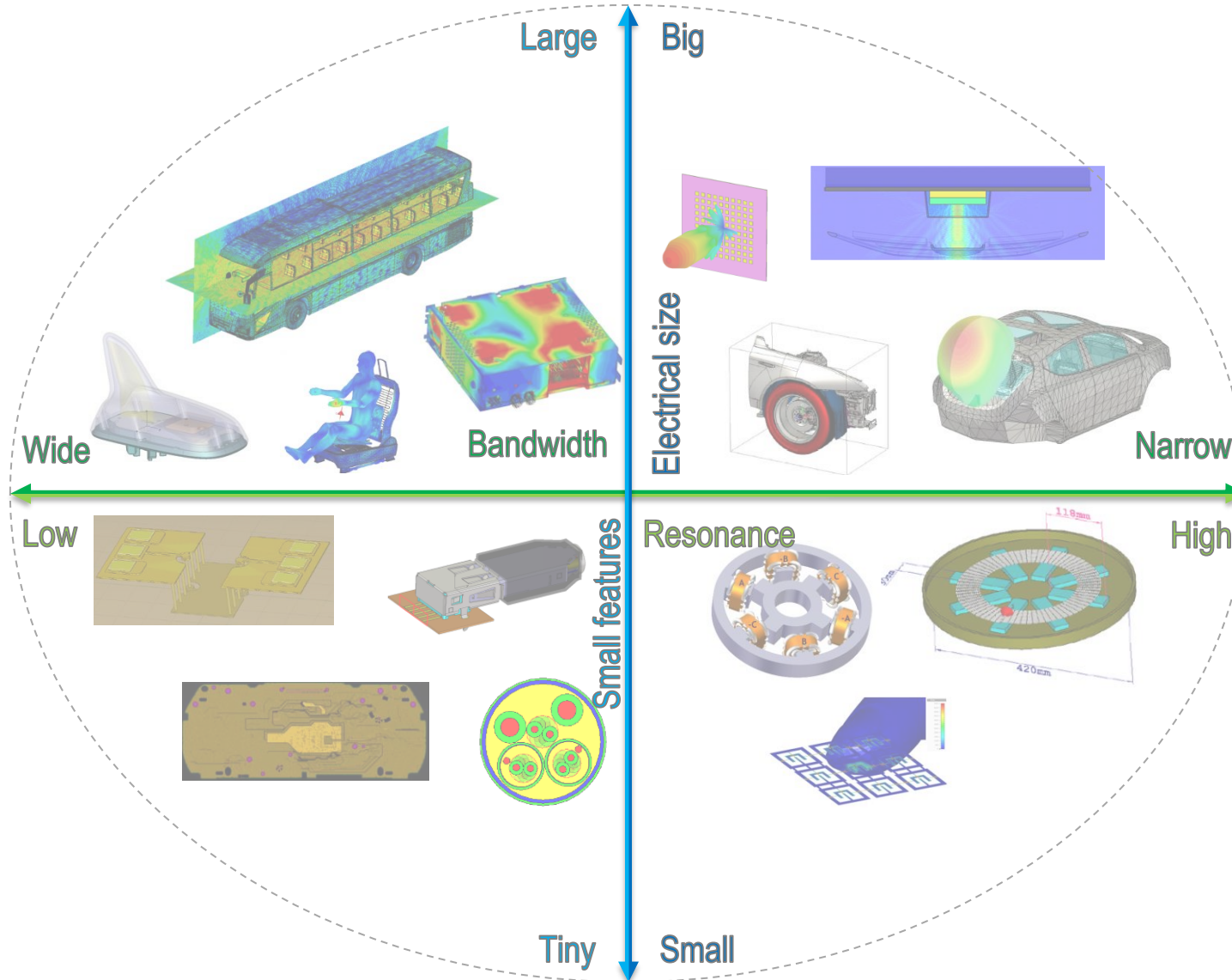
CST offers the most appropriate simulation techniques for each type of EM phenomena

EM Applications



Complete Technology for EM Simulations

The Right Solver for the Job



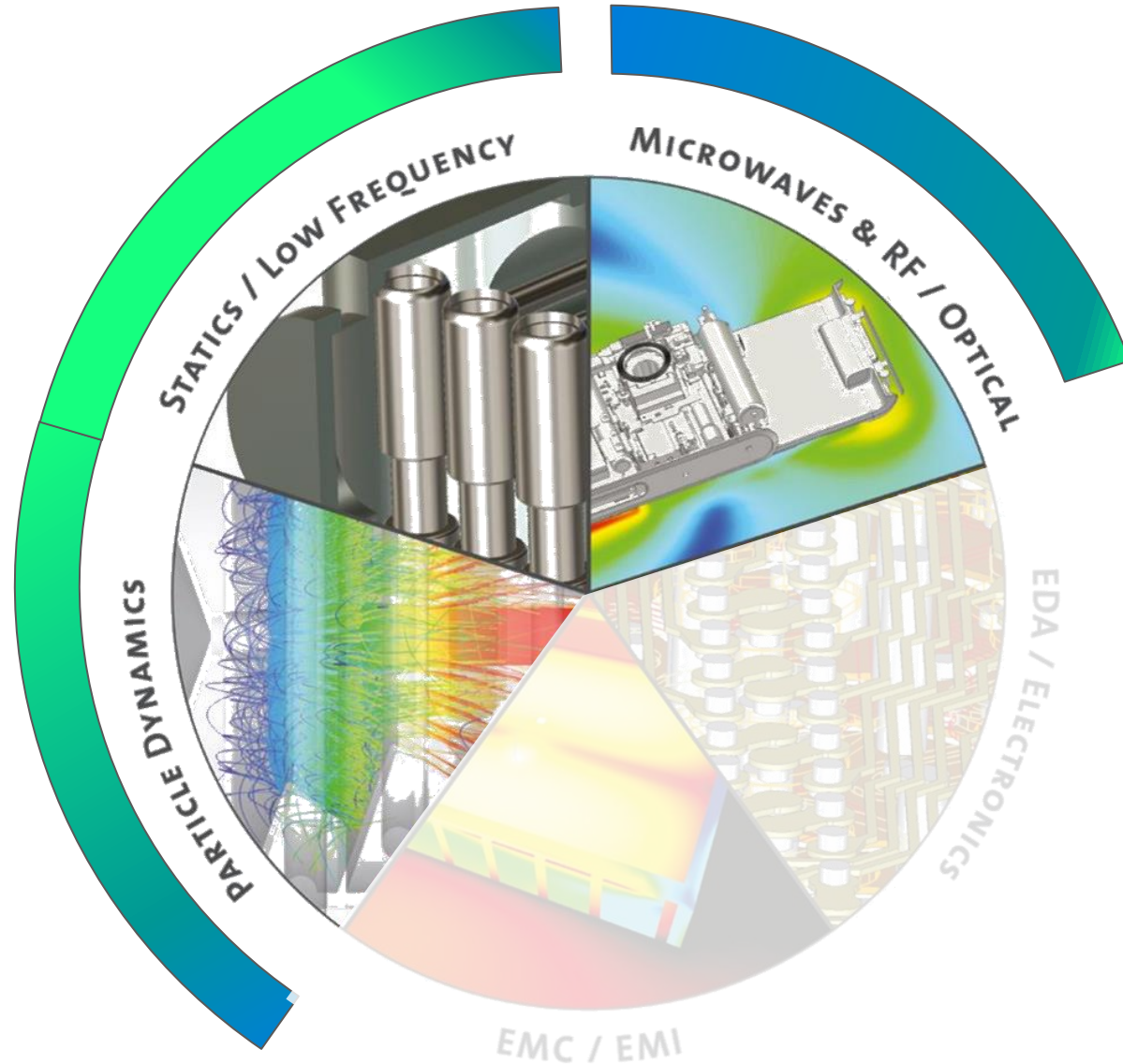
We offer the appropriate simulation techniques for a very wide range of applications.

- ▷ 4 general purpose solvers +20 application-specific solvers
- ▷ Covering EM + circuit + multiphysics
- ▷ Seamlessly integrated in the same intuitive user interface
- ▷ High performance computing features

	Time Domain Solver
	Frequency Domain Solver
	Integral Equation Solver
	Asymptotic Solver
	Eigenmode Solver
	Multilayer Solver
	E-Static Solver
	M-Static Solver
	Stationary Current Solver
	LF Frequency Domain Solver
	LF Time Domain Solver

EM Applications

High Frequency

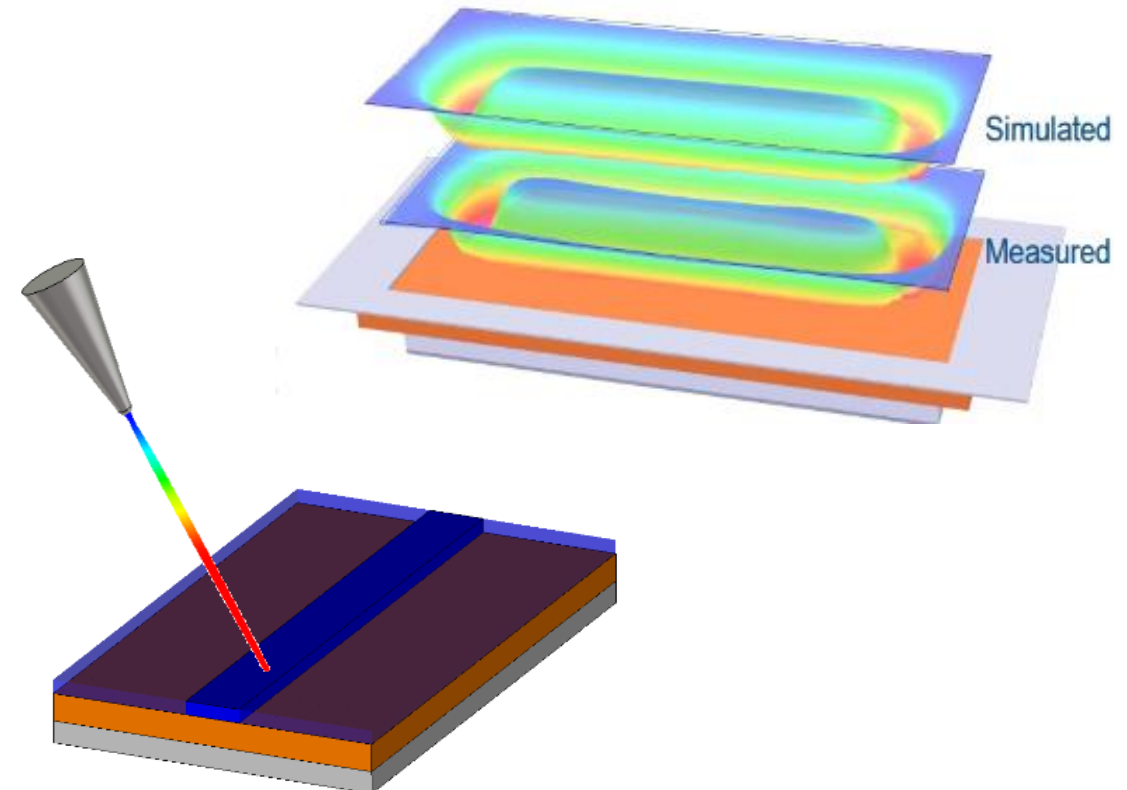
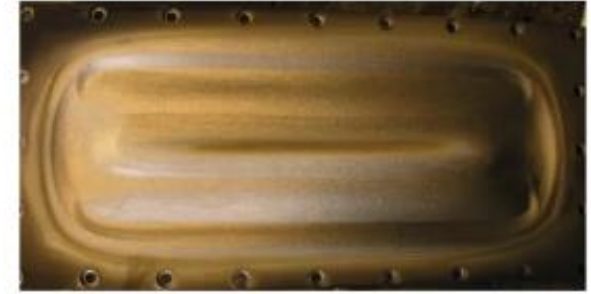


Low Frequency

Electromagnetics - Charge Particles Interaction

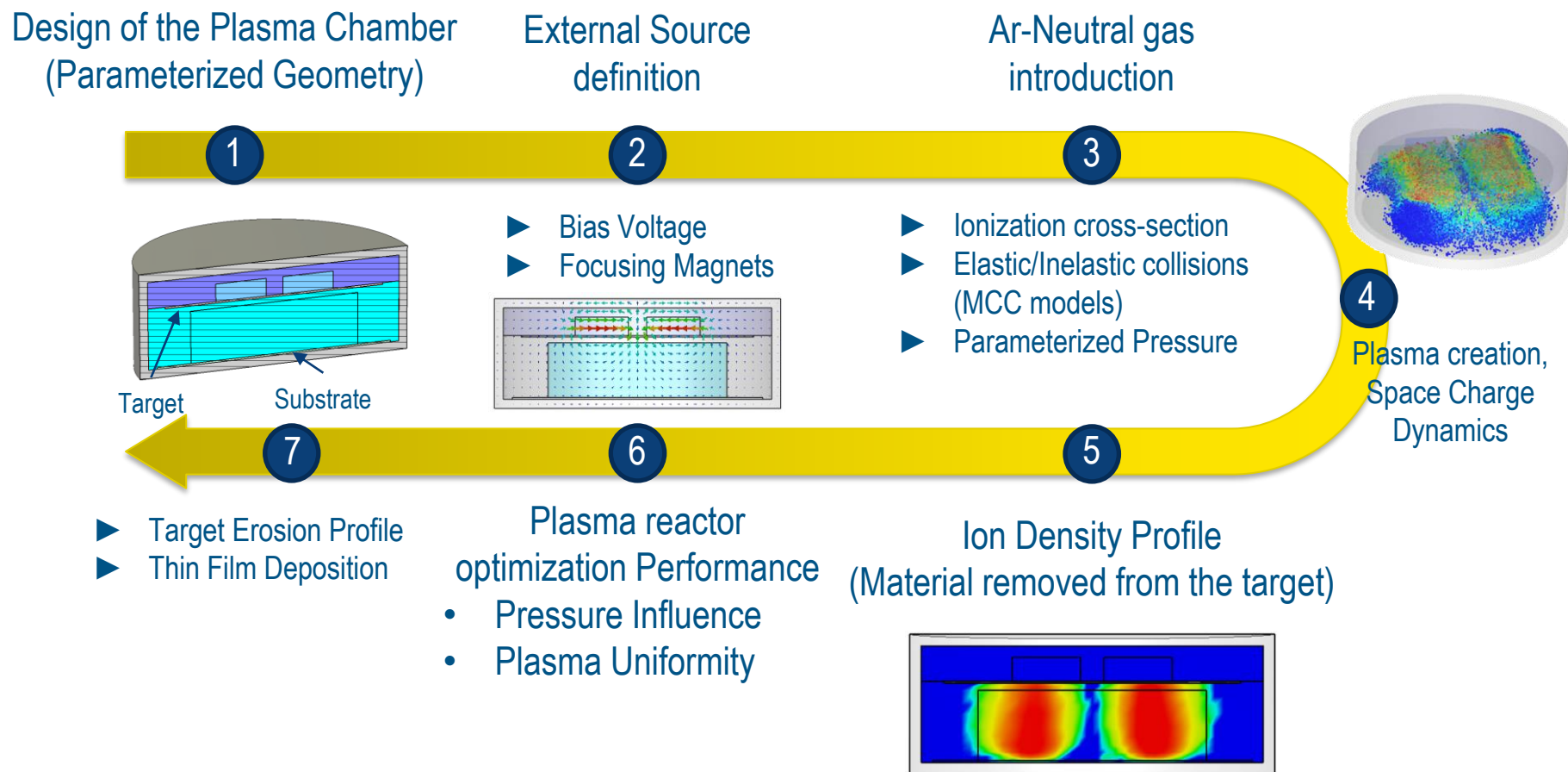
Processes used in the Manufacture of Semiconductors

- Deposition
 - Sputtering
 - Chemical Vapour Deposition, Plasma Vapour Deposition and many related methods
- Etching
 - Wet Chemical Etching & Physical abrasion
 - Dry Plasma Etching
 - Ashing (Photoresist removal & Trimming)
- Doping Process
 - Ion Implantation
- Lithography
 - E-beam Lithography – to create the masks for Extreme UV photolithography
 - Sintering Printed Circuits for Flexible Electronics



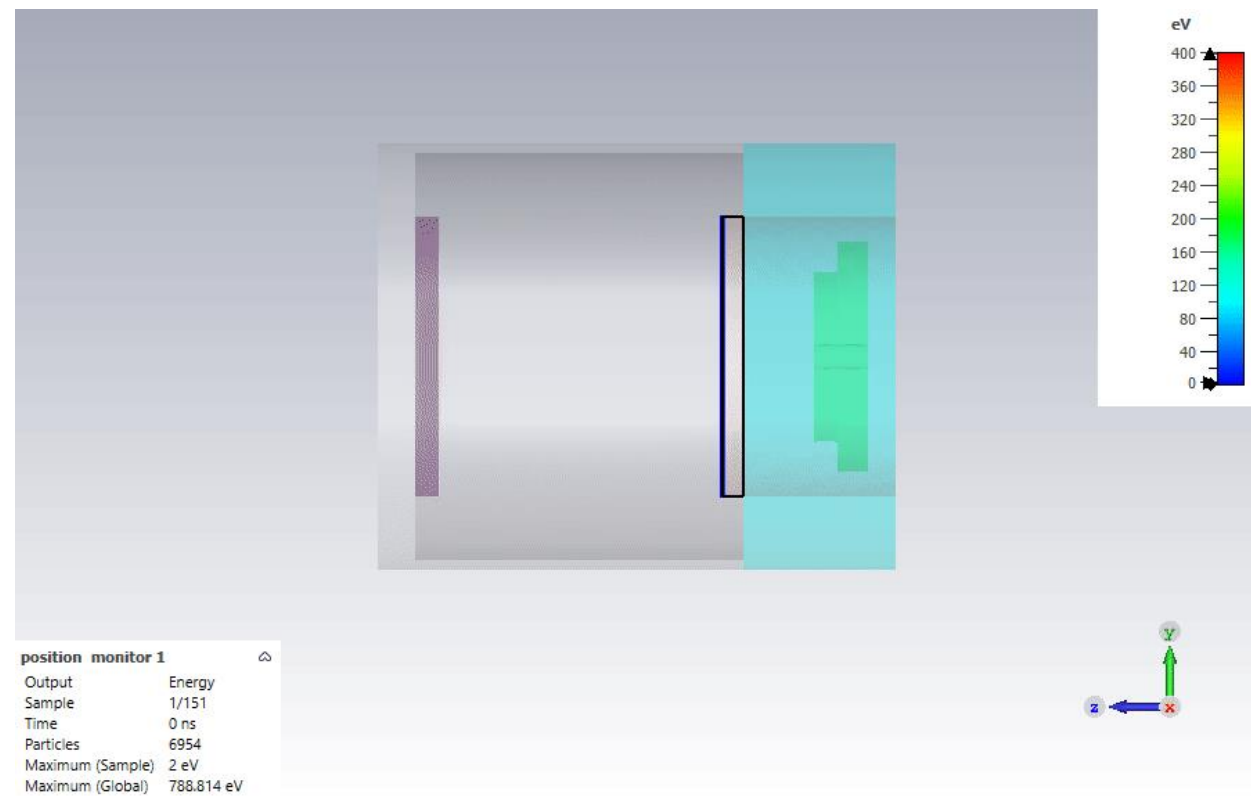
Electromagnetics-Charge Particles Interaction

- Exploring new Plasma Reactor Design
- Improving Uniformity of ion Density Profiles
- Thermal coupling analysis to prevent damage
- Exploring the effect of using different types of gases
- Pressure and External sources effects on the Plasma homogeneity
- High Fidelity modeling to predict/explain experimental results when no diagnostics are available
- Plasma modelling & Space Charge Dynamics interaction
- Transient effects

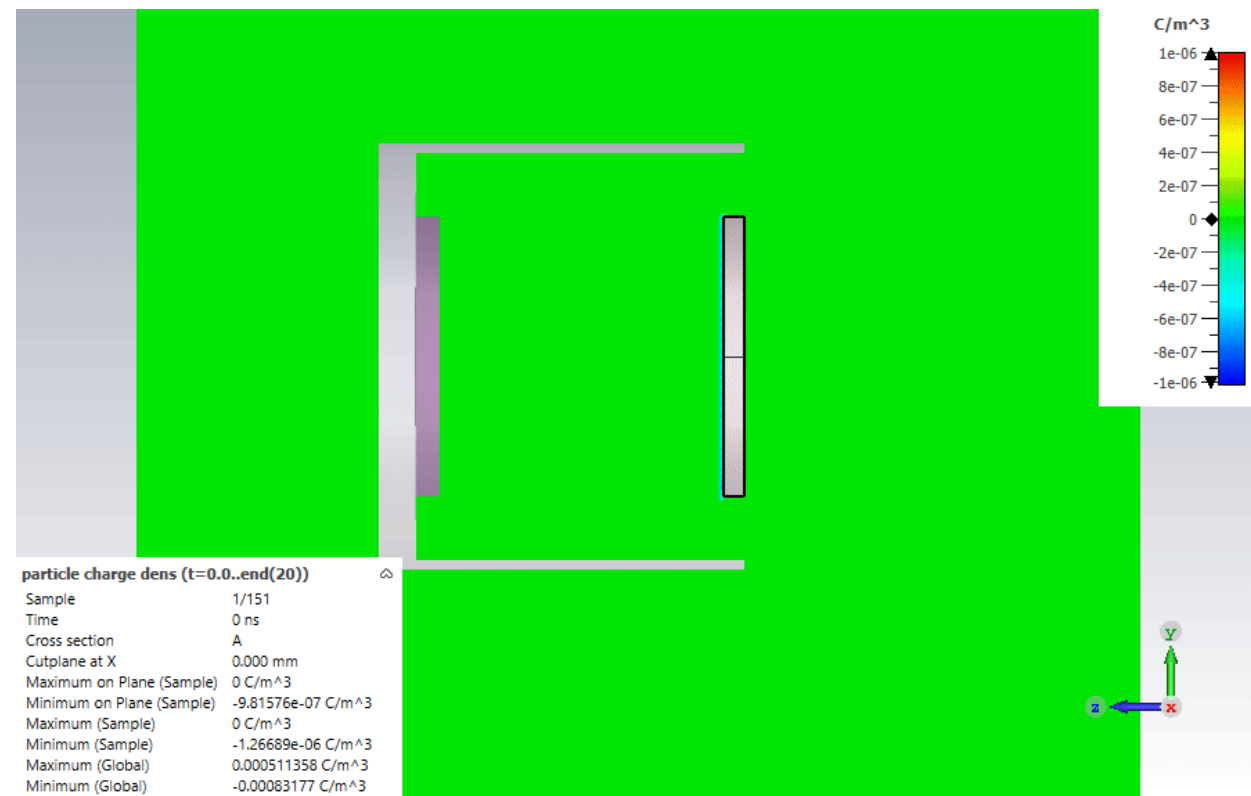


Electromagnetics - Charge Particles Interaction

Plasma Ignition – Transient behavior



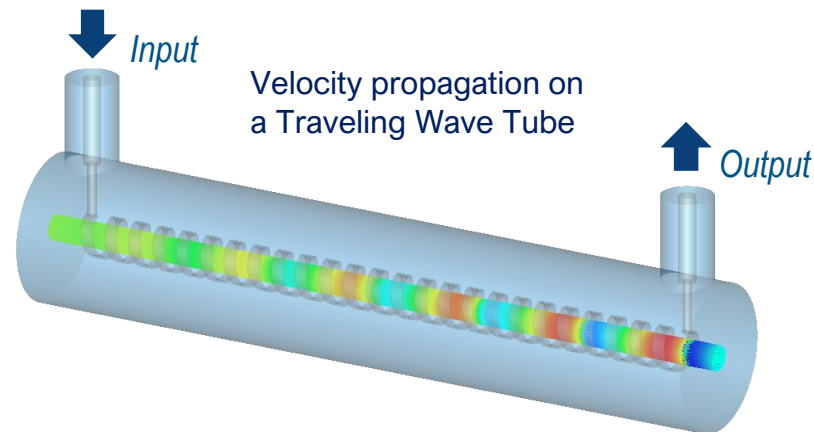
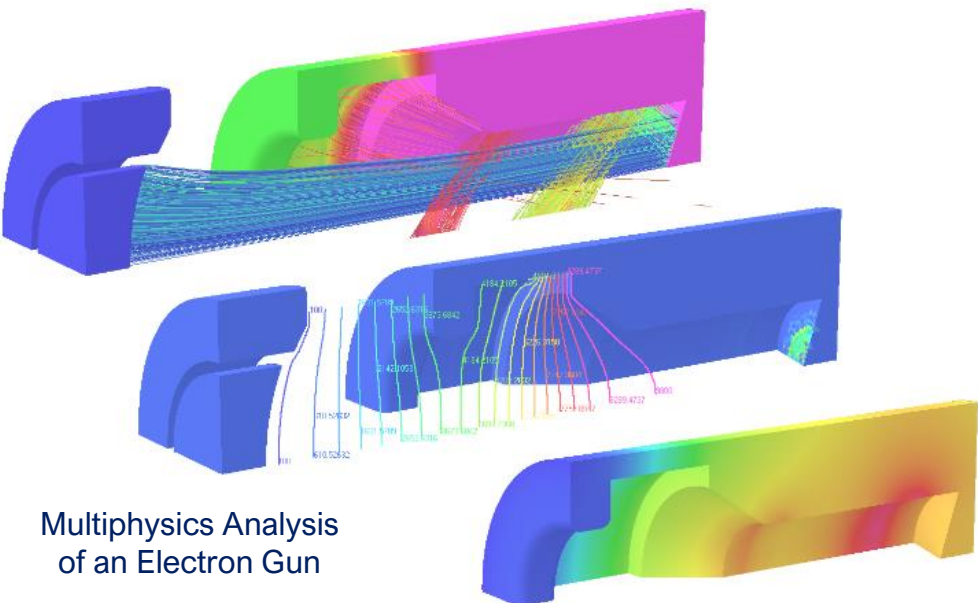
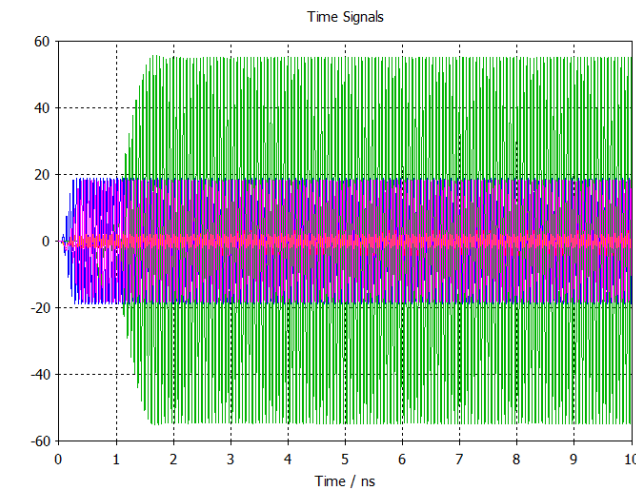
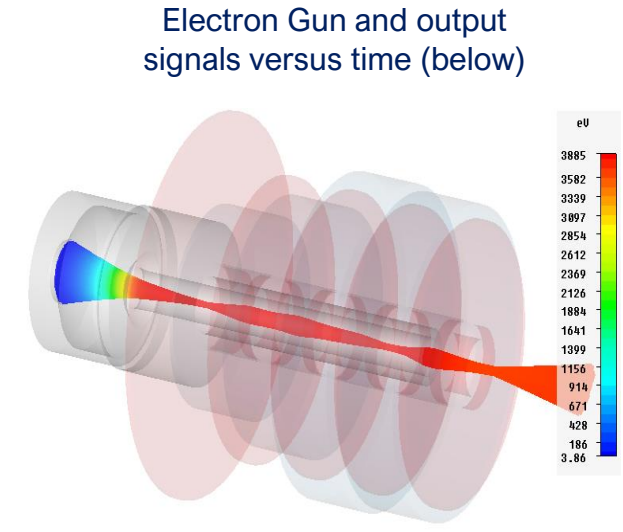
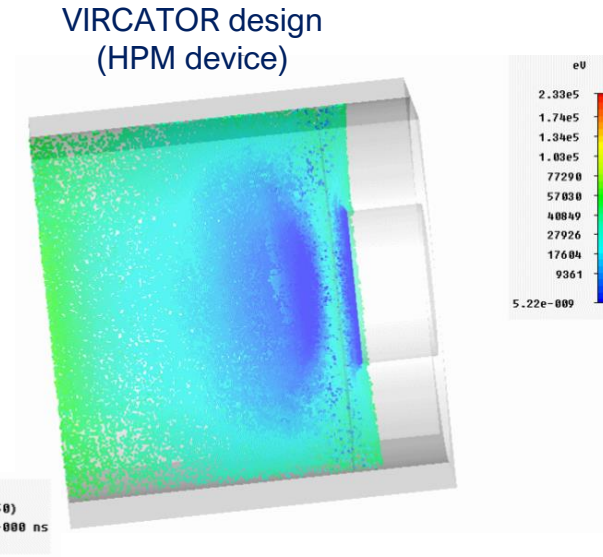
Plasma Expansion and Particle energy concentration at the Target surface



Electron & Ion beam Profiles with evidence of Ar-Ion bombardments on the Target surface

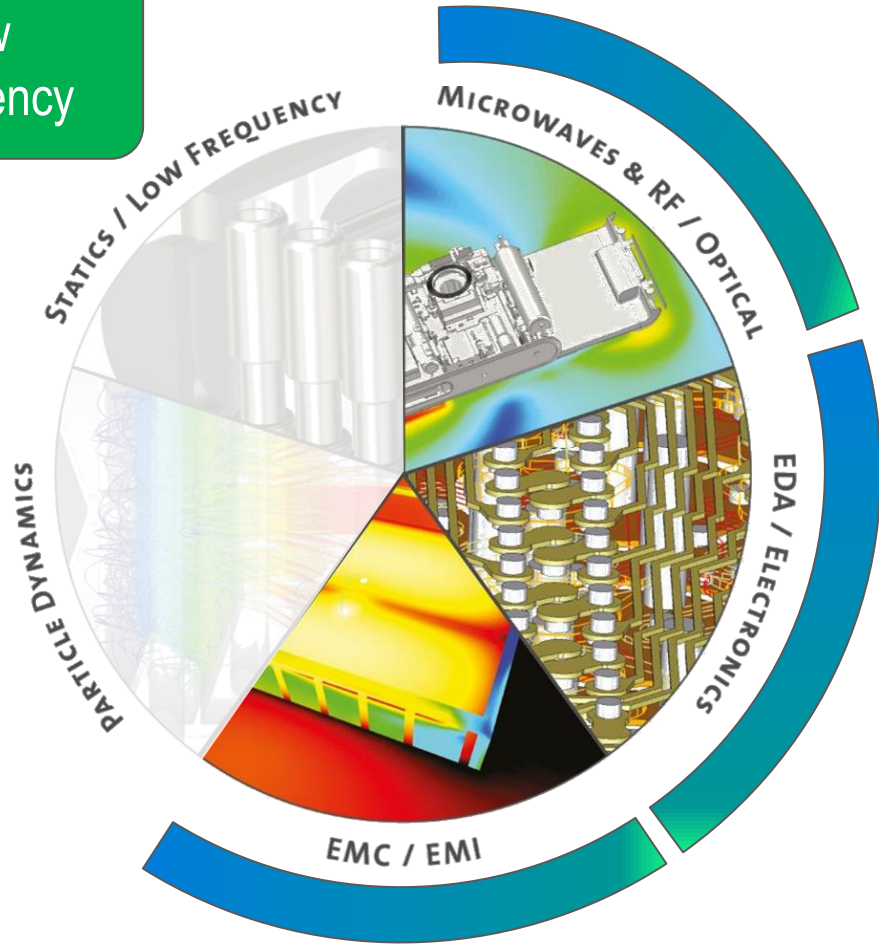
Electromagnetics - Charge Particles Interaction

- Satellite communication
- Radar Systems
 - ⇒ Vacuum electron Devices (TWT, Klystrons, etc...)
- Emission Models for Primary and Secondary particles
- High Power Microwave (HPM) generation
 - ⇒ Compact Relativistic vacuum electron Devices
- Streak Cameras for night vision
 - ⇒ Photon-electron conversion (Photoelectric effect)
- Manipulation of Charge particle beams with Magnets
- Multiphysics – beam-heating-deformation



EM Applications

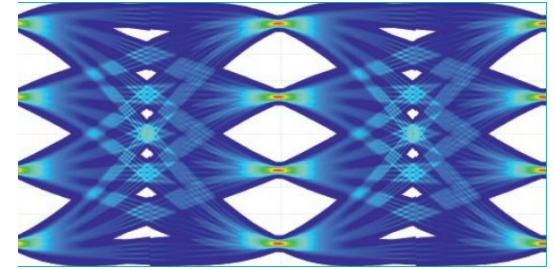
Low Frequency



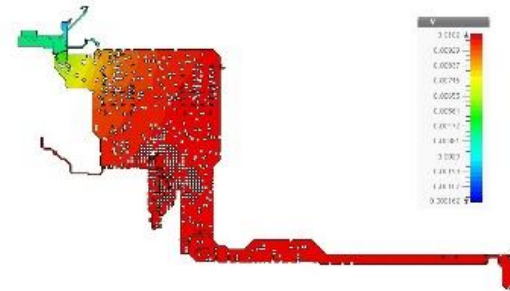
High Frequency

EDA / Electronics and EMC

Signal Integrity



Power Integrity

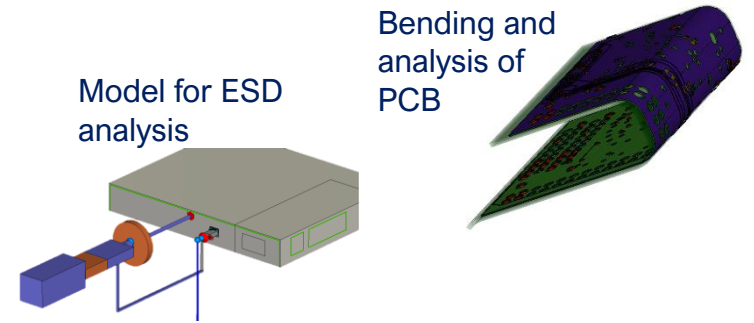


EMC

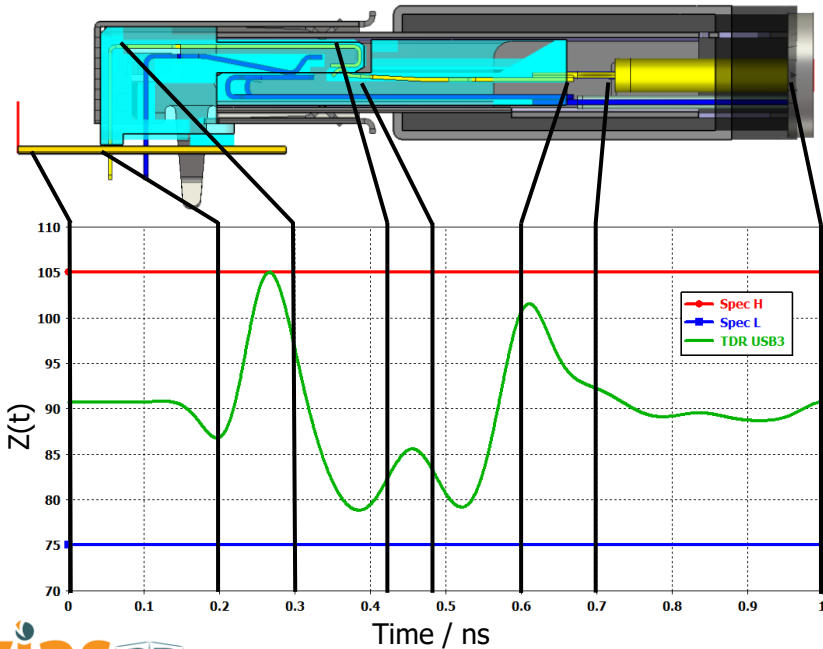


Electronics Design Analysis

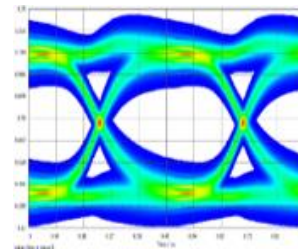
- Time-Domain Refractory (TDR) analysis.
- Visualization of Electromagnetics (EM) fields and losses.
- Analysis of Signal and Power Integrity of PCBs.
- EM compatibility and interference compliance check.
- Electrostatic Discharge (ESD), Lightning and EMP analysis.
- Radiated and Conducted emission, Electromagnetic Immunity analysis on complex cable structures and connectors.



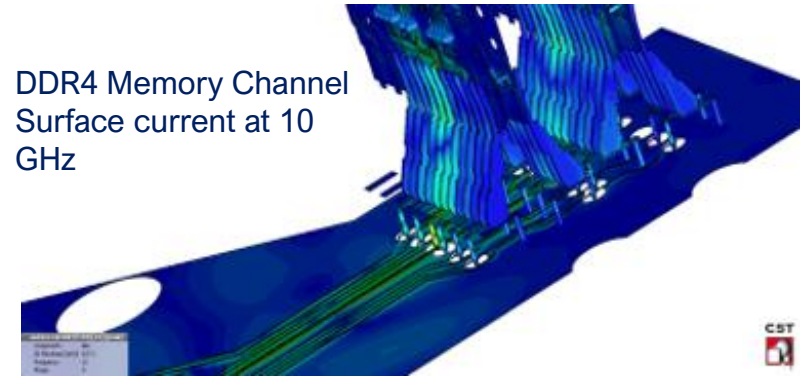
Impedance profile versus time on connectors and lines



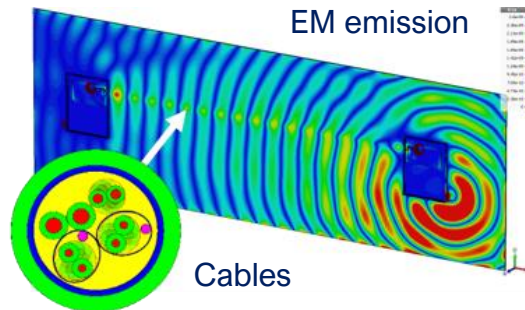
Eye Diagram



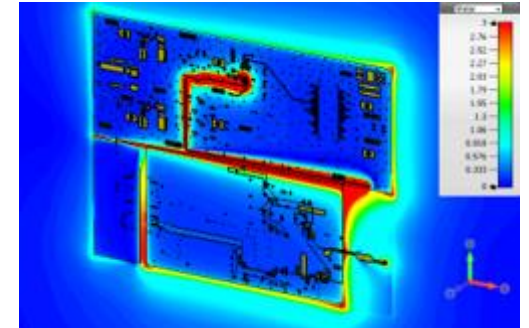
DDR4 Memory Channel Surface current at 10 GHz



EM emission



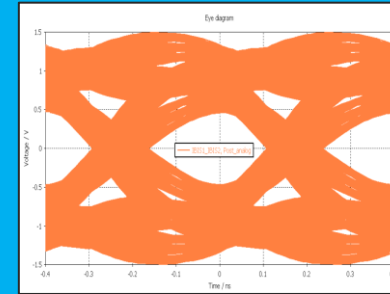
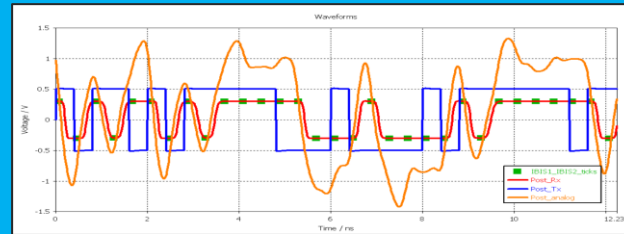
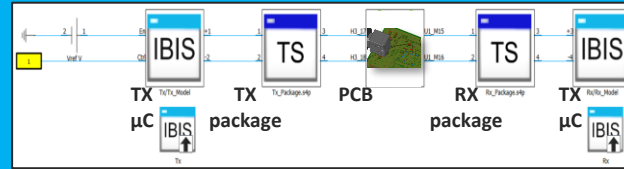
EM PCB Losses



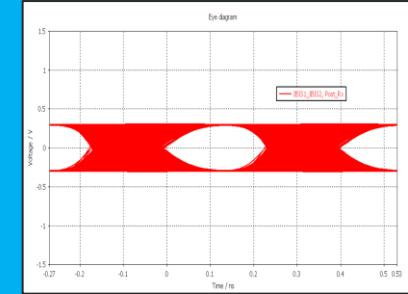
Signal Integrity, Power Integrity and EMC

Signal Integrity Issues

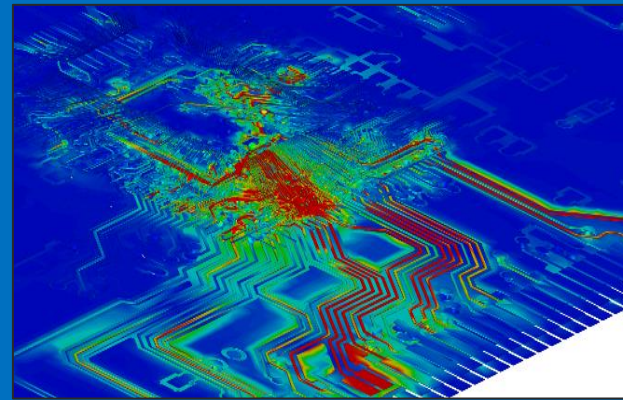
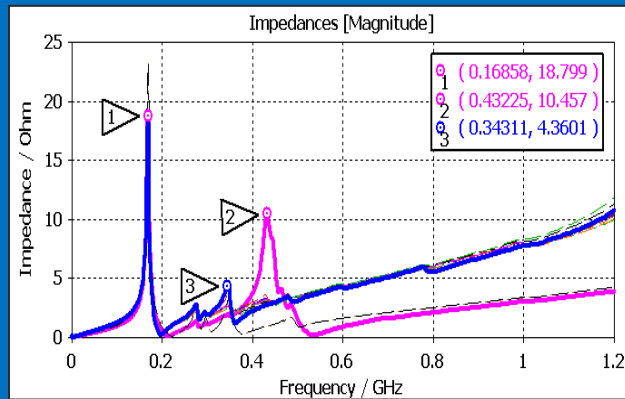
- Ringing
- Crosstalk
- Distortion
- Signal loss
- Power supply noise



Eye Diagram
Before
Equalization & Clock Recovery



Eye Diagram
After
Equalization & Clock Recovery

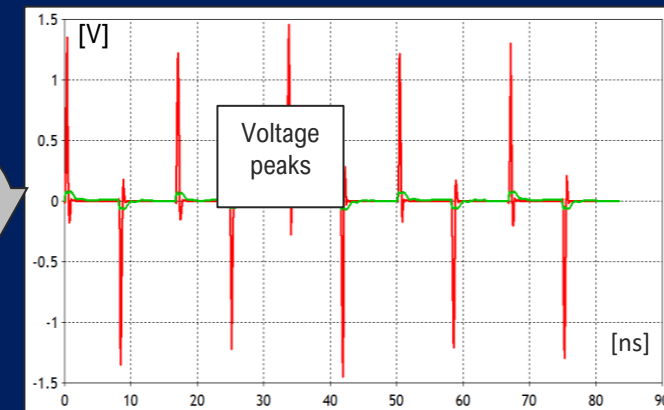
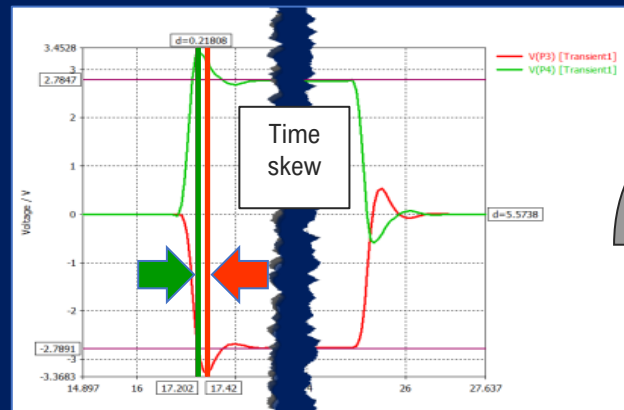


Power Integrity Issues

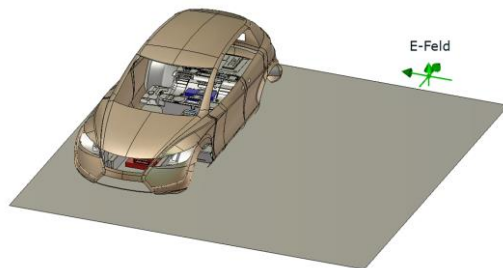
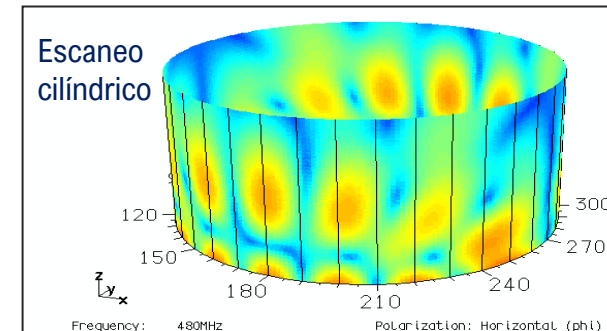
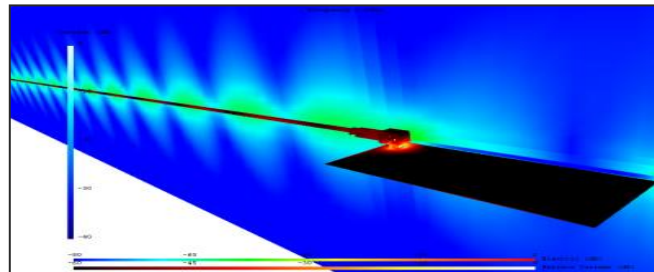
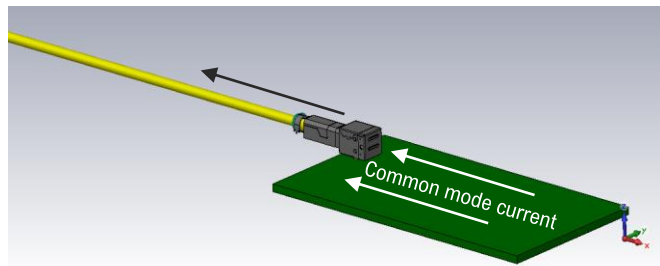
- Simultaneous switching noise
- Ground bounce
- High impedance
- Resonance

EMC Issues

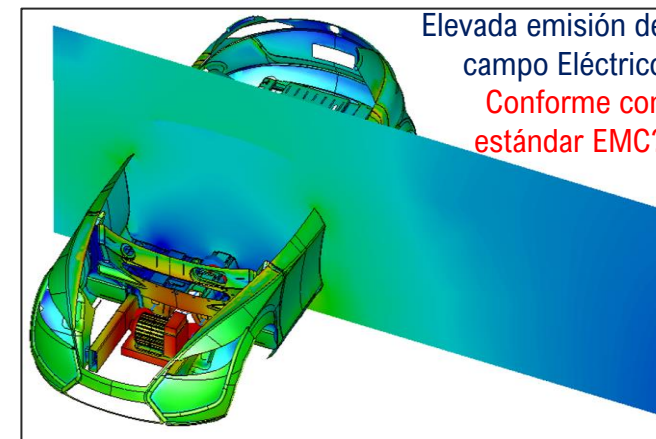
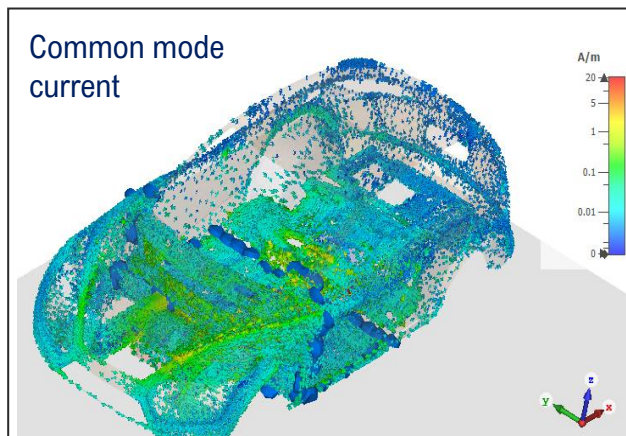
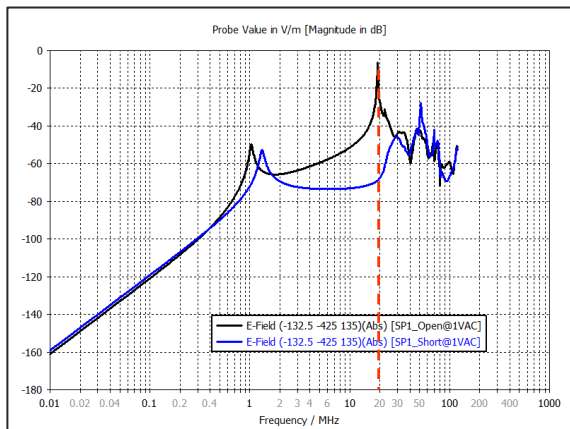
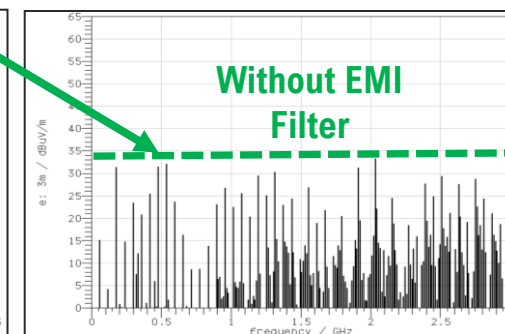
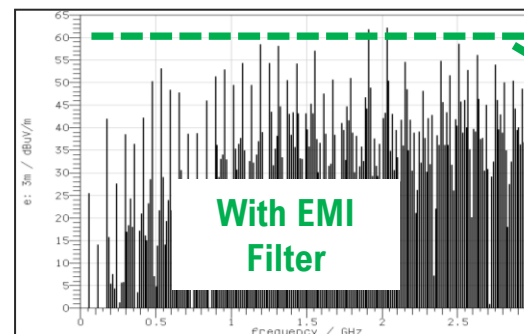
- Imbalances
- Time skew
- Common mode currents
- Conducted emissions
- Radiated emissions



Effect of Conducted and Radiated Emissions

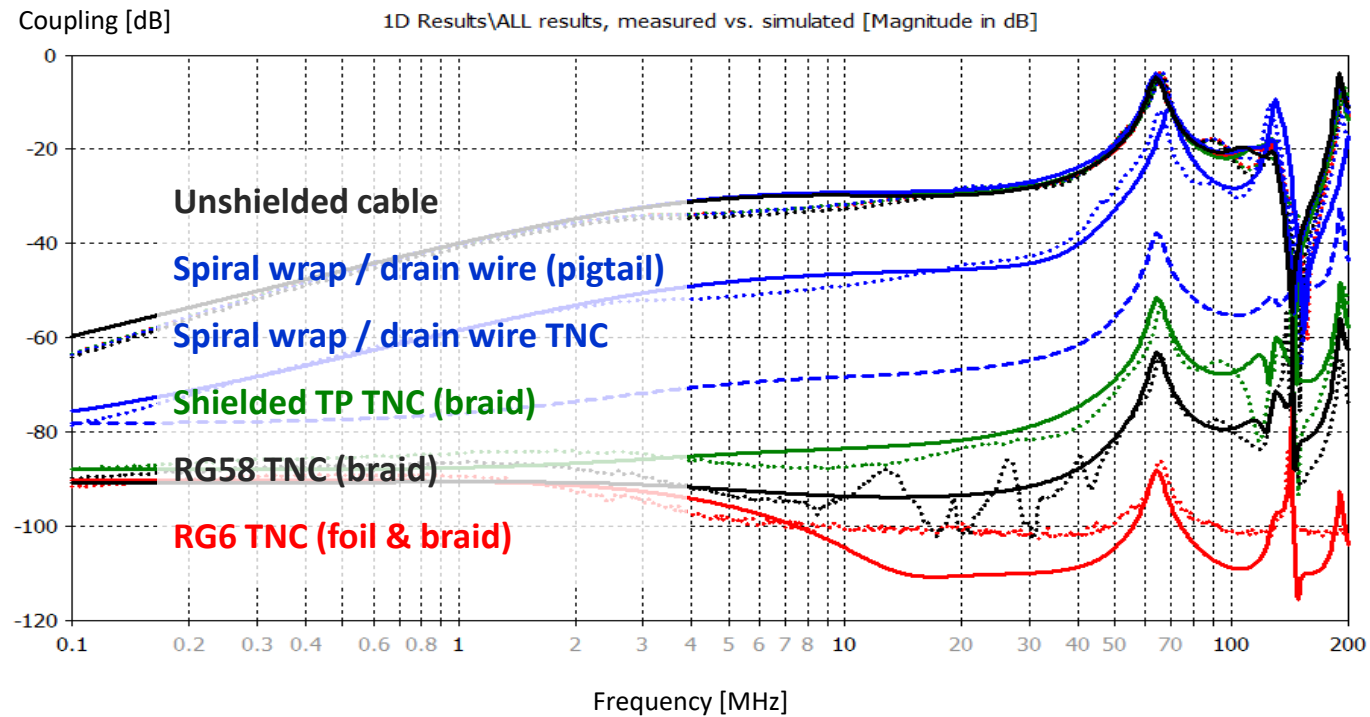
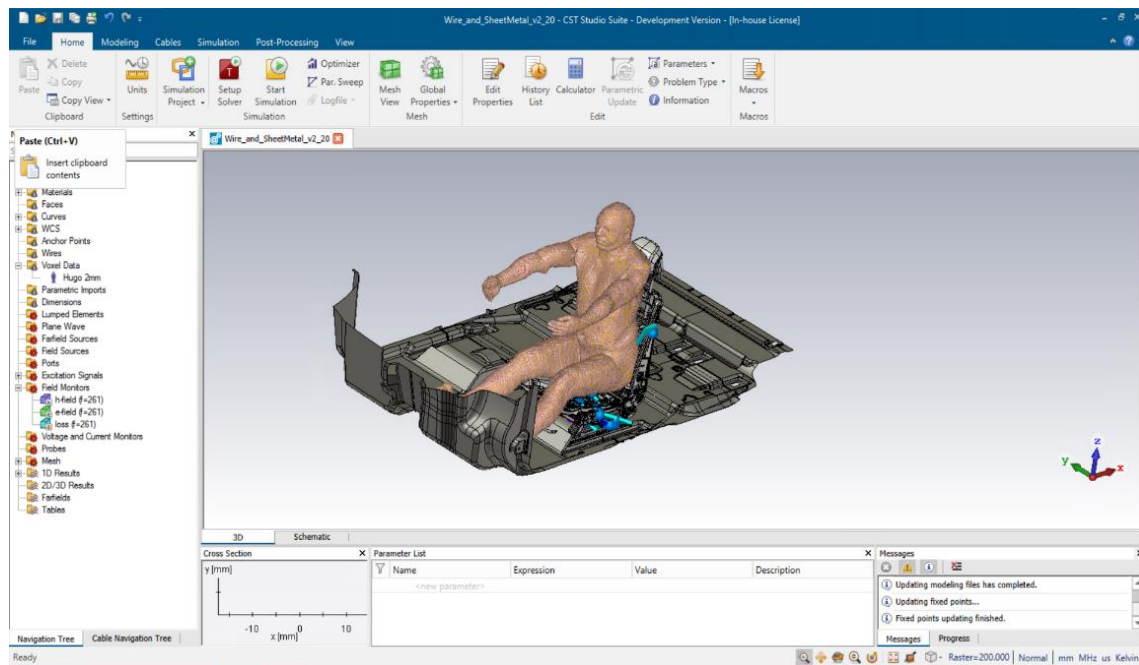
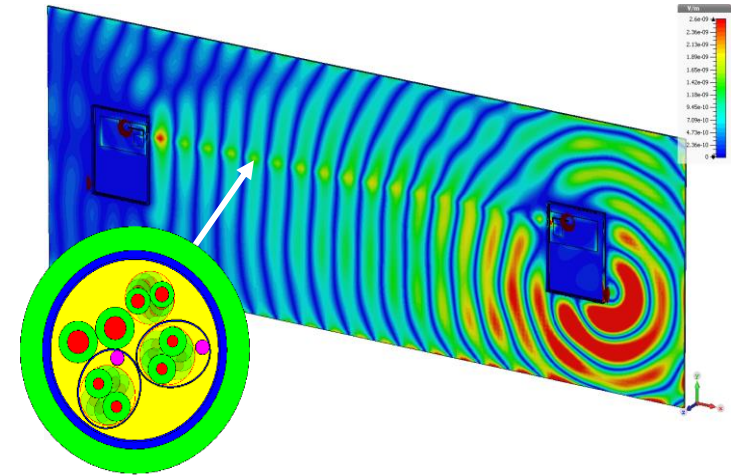


Conducted Emission Analysis



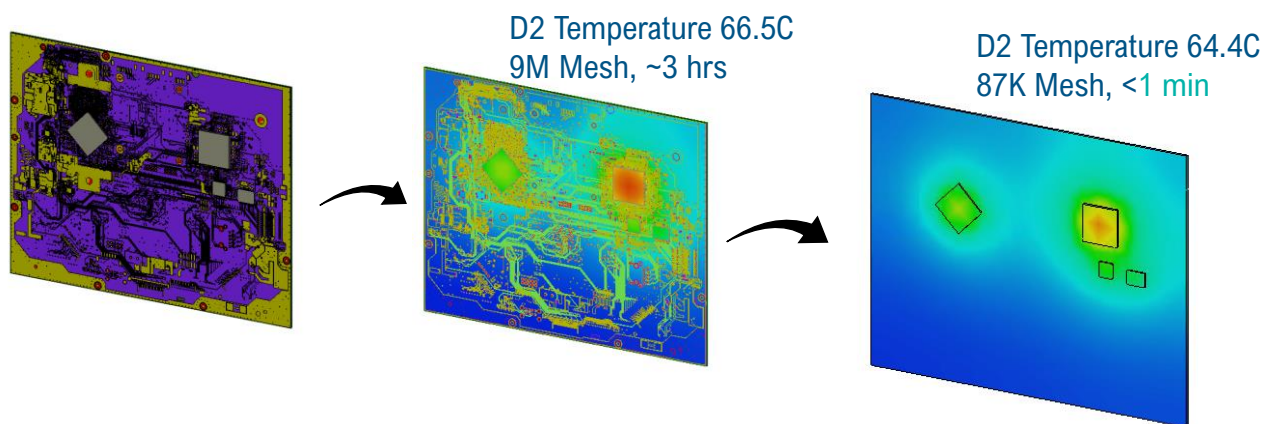
Harness & Electrical Wiring

- Component level & System level Analysis
- Interconnects and connectors modelled & simulated in full 3D
- High bandwidth, high frequency applications (Automotive Ethernet)
- Import wire harness data, complex cross section definition and Material & cable type libraries available.
- S-Parameters, propagation delay, cross talk, signal & power integrity, transfer impedance, etc...
- EMC/EMI analysis of cables.
- Full 3D shield modelling and library of shield types.
- Human Exposure Simulation, SAR calculation, Radiation Hazards.

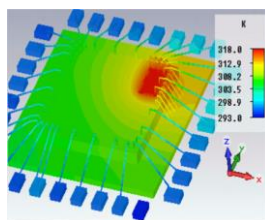


EM-Thermal and Stress Analysis

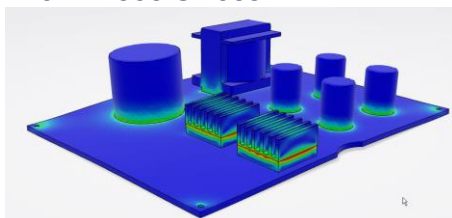
- Perform Multiphysics analyses involving EM-Thermal-Mechanical problems.
- Steady state, transient and Conjugate Heat Transfer solvers.
- Uni-directional and Bi-directional coupling.
- Automatic layer simplification (average material properties).
- Components modeling.



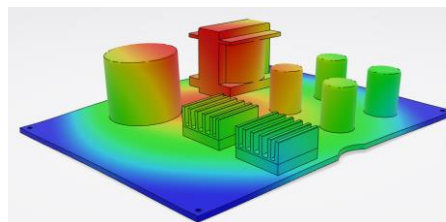
Temp. distribution on IC/Packages



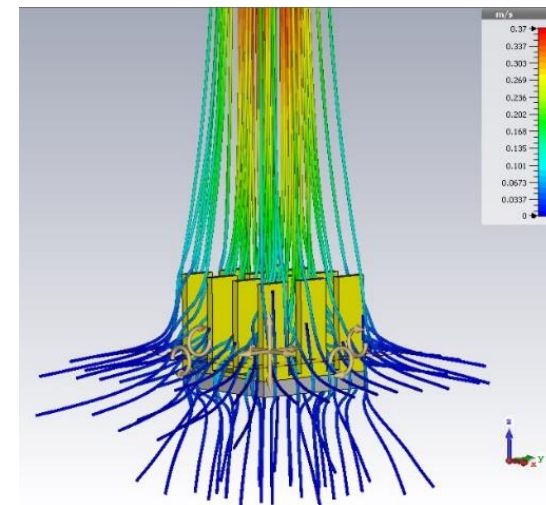
Von Mises Stress



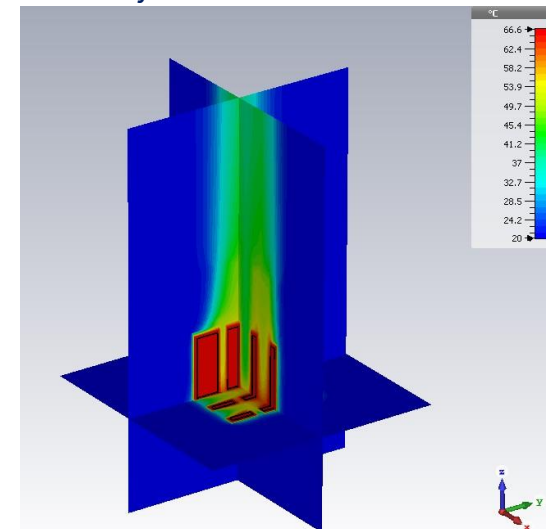
Deformation



Temperature



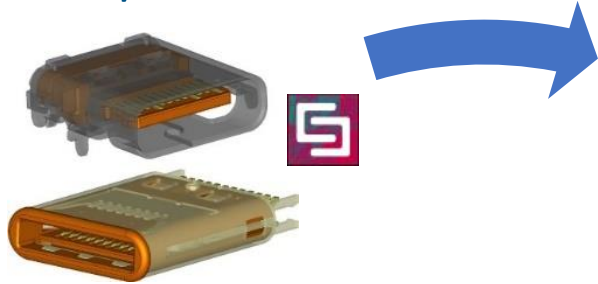
Velocity



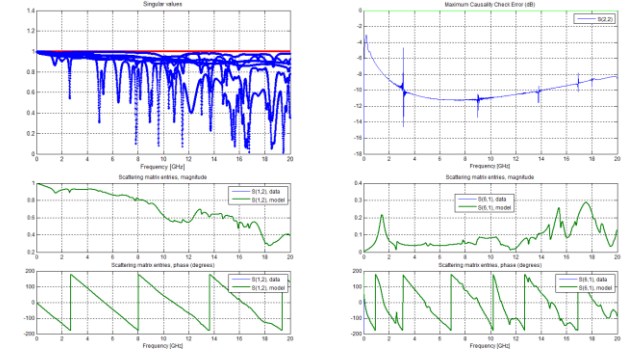
IdEM-based simulation flow



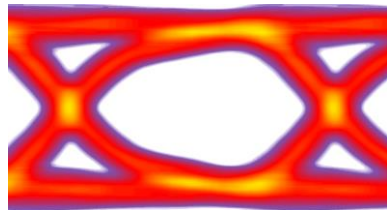
EM Simulation / Measurements



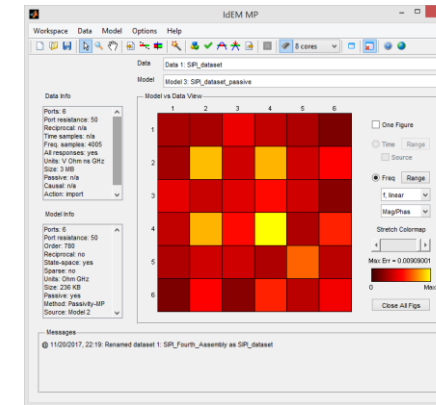
$S(f)$ Touchstone







SI/PI analysis



IdEM



-  ✓ Data certification
-  ✓ Rational approximation
-  ✓ Passivity enforcement
-  ✓ Synthesis

Circuit solver



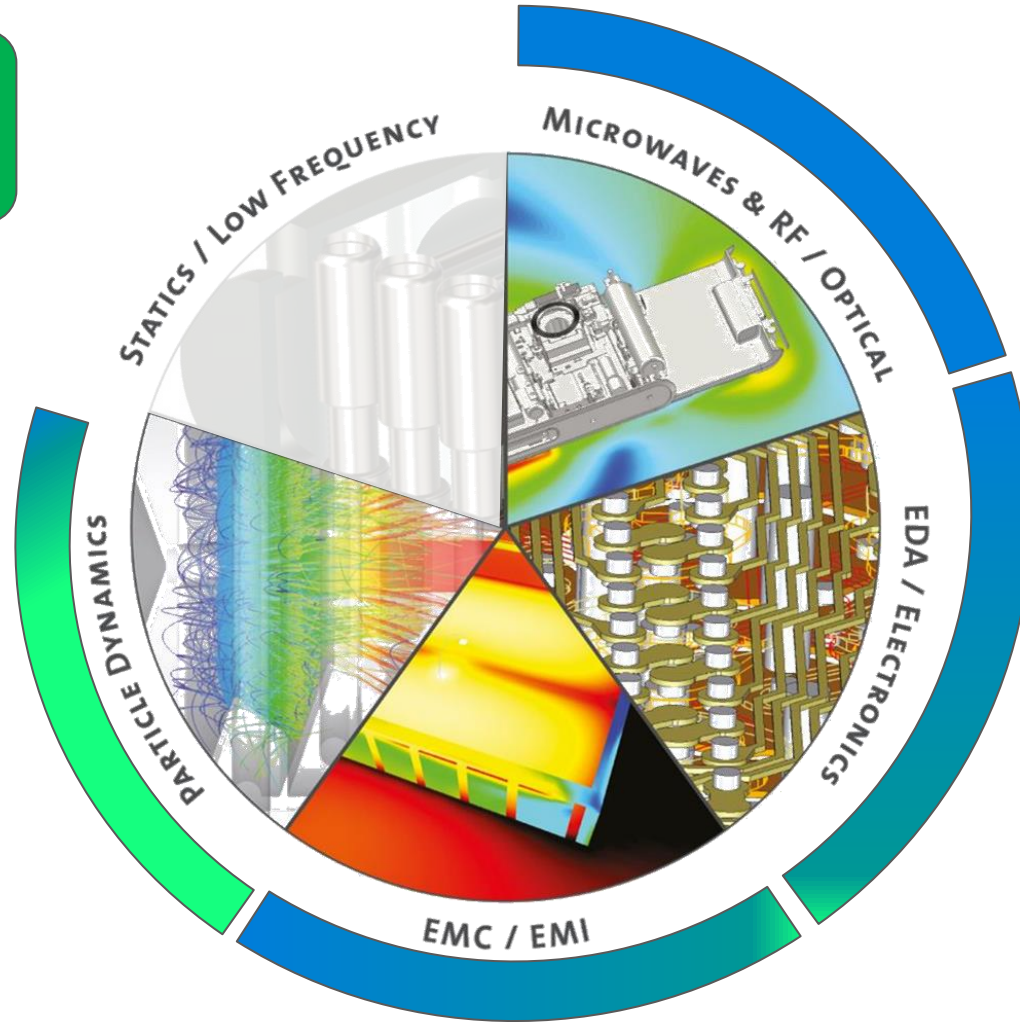
Time domain simulation

Passive and Causal Macromodel



EM Applications

Low
Frequency



High Frequency

Antenna engineering & certification

AntennaMagus
Explore.Design.Deliver.

Crossed exponentially tapered slot antenna	CPW-fed annular monopole antenna	Planar four-arm sinusoidal antenna	Conical four-arm sinusoidal antenna

Simulation and Optimization. 3D Model Completely Parametrized.

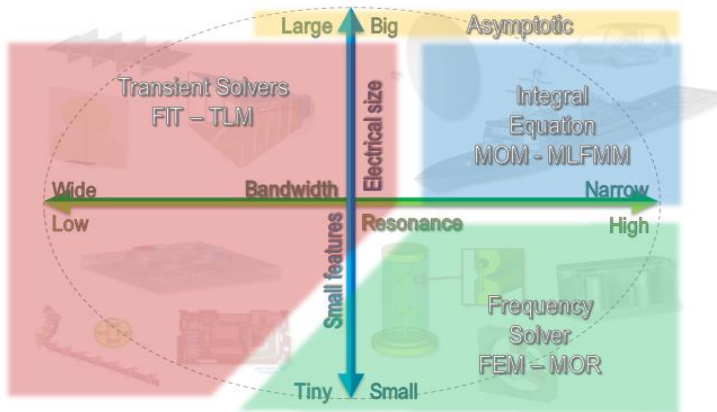
Installed Antenna Performance

CST Studio Suite 2021

3DEXPERIENCE
The 3DEXPERIENCE Company

Waveguide (Horn, Cone, etc.)	Planar (Patch, Slot, etc.)
Wire	Phased Array, Unit Cell
Mobile Phone, Integrated	Reflector
Dielectric Resonator	RFID

Complete Technology for solving EM problems, hybrid simulation, all included in one GUI.



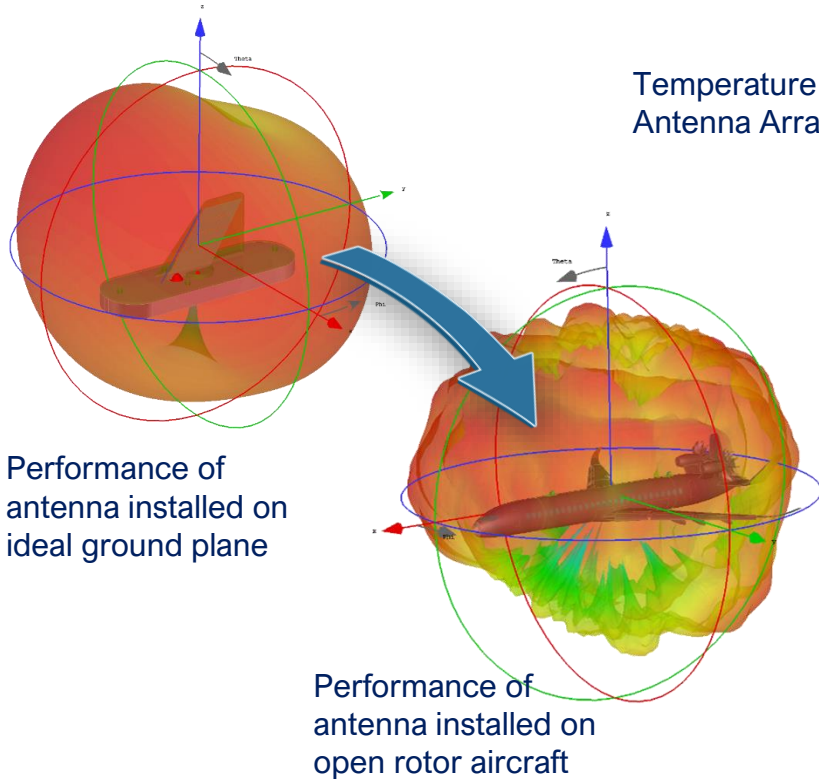
AM Input Signal at RFID Reader

LF Signals at RFID Tag 3

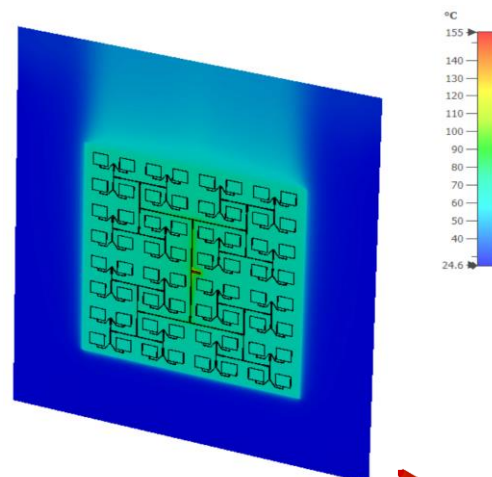
Circuit and System Simulation

Antenna engineering & certification

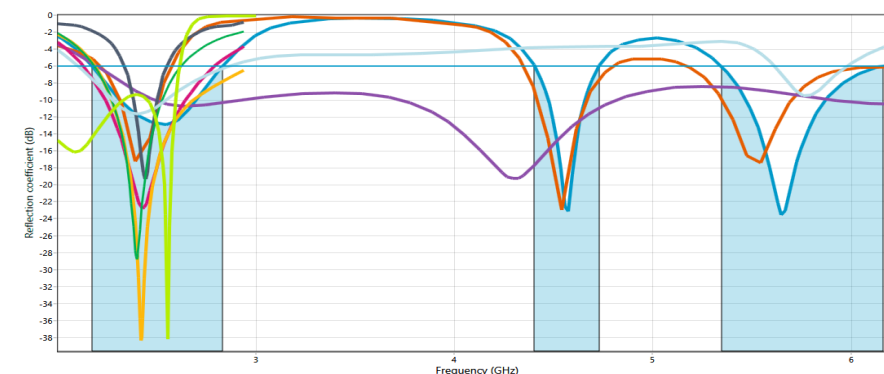
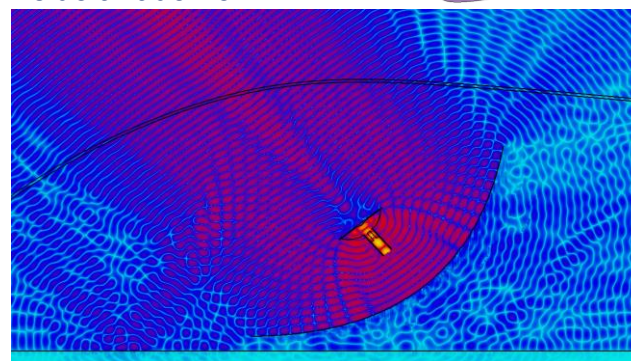
- Find, design/tweak, evaluate and export validated simulation-ready antenna design models.
- Synthesized and analyze antenna arrays.
- Evaluate installed performance and optimize antenna placement.
- Antenna radome analysis.
- Mitigate co-site interference.
- Perform Multiphysics analysis.



Temperature on an Antenna Array



Reflector antenna placed inside a radome



	WLAN 2.4 (802.11b/g/n) 1	WLAN 2.4 (802.11b/g/n) 1	WLAN 2.4 (802.11b/g/n) 1	WLAN 2.4 (802.11b/g/n) 1	WLAN 2.4 (802.11b/g/n) 1	WLAN 2.4 (802.11b/g/n) 1	WLAN 2.4 (802.11b/g/n) 1	WLAN 2.4 (802.11b/g/n) 1
	Port 1	Port 1	Port 1	Port 1	Port 1	Port 1	Port 1	Port 1
Bandwidth (below the -6.0 dB level)	654.9 MHz	362.9 MHz	7.401 GHz	213.6 MHz	663.8 MHz	749.6 MHz	438.4 MHz	756.1 MHz
Bandwidth (%)	26.14 %	15.14 %	4.366	8.734 %	26.95 %	29.22 %	18.21 %	30.40 %
Bandwidth (below the -6.0 dB level)	325.6 MHz	457.7 MHz	-	-	-	-	-	368.6 MHz
Bandwidth (%)	7.128 %	9.998 %	-	-	-	-	-	6.357 %
Bandwidth (below the -6.0 dB level)	814.5 MHz	10.48 GHz	-	-	-	-	-	-
Bandwidth (%)	14.15 %	3.027	-	-	-	-	-	-

Designs - 3.4GHz - 3.8GHz options

- Meander Monopole Custom Specification 1
- Double-T Custom Specification 1
- Trap Monopole 3GPP Band 42 and 43 (top middle)
- Planar IFA 3GPP Band 42 and 43 (top middle)
- Compact IFA Custom Specification 1
- Compact Monopole Custom Specification 1
- M Monopole Custom Specification 1
- Folded Half Loop Custom Specification 1

Thumbnail 1: Trap Monopole - 3GPP Band 42 and 43 (top middle). Dimensions: Z: 7.054 mm, X: 11.24 mm, Y: 11.39 mm. Spatial Limits: X: 10 mm, Y: 20 mm, Z: 2 mm.

Thumbnail 2: Meander Monopole - Custom Specification 1. Dimensions: Z: 8.843 mm, X: 11.62 mm. Spatial Limits: X: 10 mm, Y: 20 mm, Z: 2 mm.

Thumbnail 3: Double-T - Custom Specification 1. Dimensions: Z: 6.322 mm, Y: 10.24 mm, X: 6.576 mm. Spatial Limits: X: 10 mm, Y: 20 mm, Z: 2 mm.

Thumbnail 4: Compact IFA - Custom Specification 1. Dimensions: Z: 1.349 mm, X: 17.63 mm, Y: 4.407 mm. Spatial Limits: X: 20 mm, Y: 10 mm, Z: 2 mm.

Thumbnail 5: Planar IFA - 3GPP Band 42 and 43 (top middle). Dimensions: Z: 4.143 mm, X: 17.68 mm, Y: 3.415 mm. Spatial Limits: X: 20 mm, Y: 10 mm, Z: 2 mm.

Thumbnail 6: Compact Monopole - Custom Specification 1. Dimensions: Z: 7.357 mm. Spatial Limits: X: 10 mm, Y: 20 mm, Z: 2 mm.

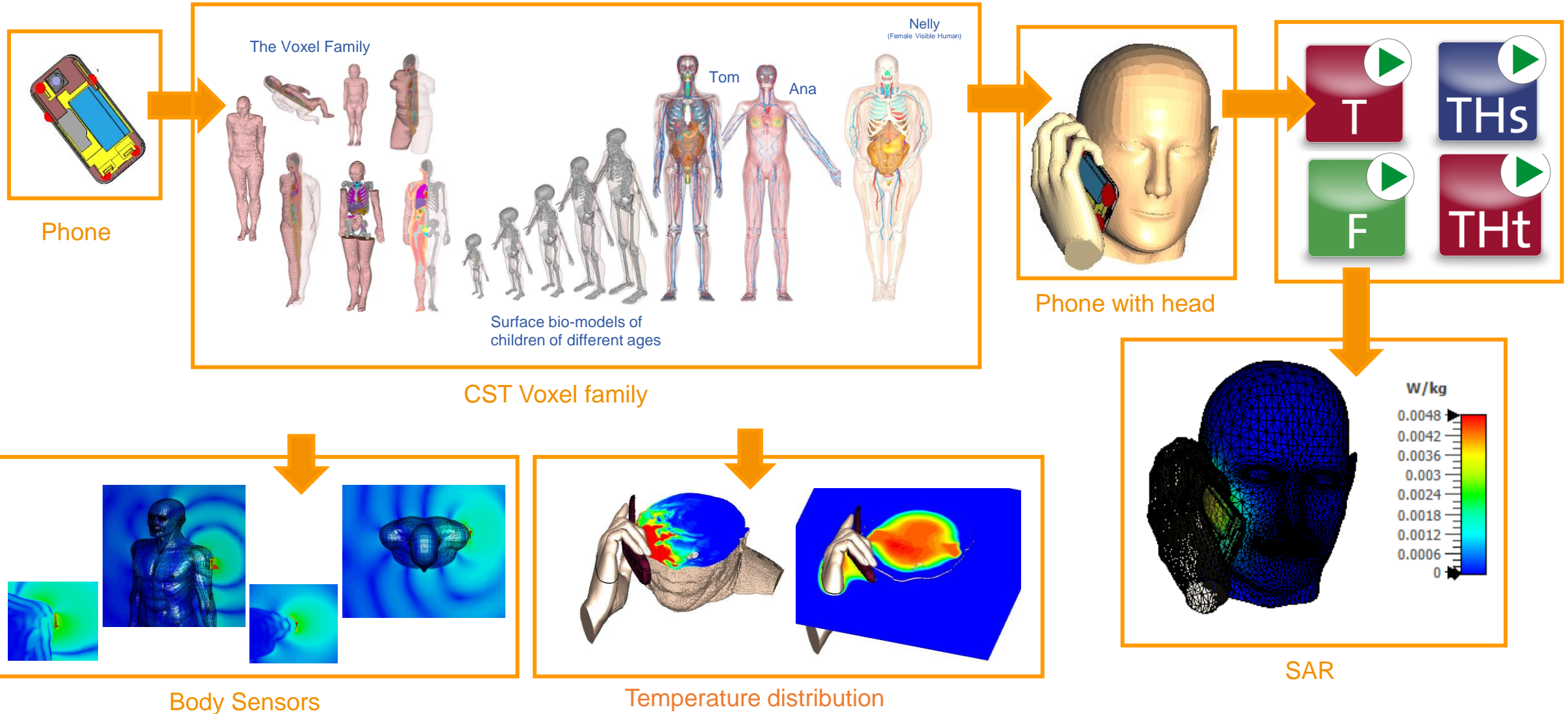
Thumbnail 7: M Monopole - Custom Specification 1. Dimensions: Z: 11.16 mm, X: 14.71 mm, Y: 6.62 mm. Spatial Limits: X: 20 mm, Y: 10 mm, Z: 2 mm.

Thumbnail 8: Folded Half Loop - Custom Specification 1. Spatial Limits: X: 20 mm, Y: 10 mm, Z: 2 mm.

Thumbnail 9: IFA - Custom Specification 1. Spatial Limits: X: 20 mm, Y: 10 mm, Z: 2 mm.

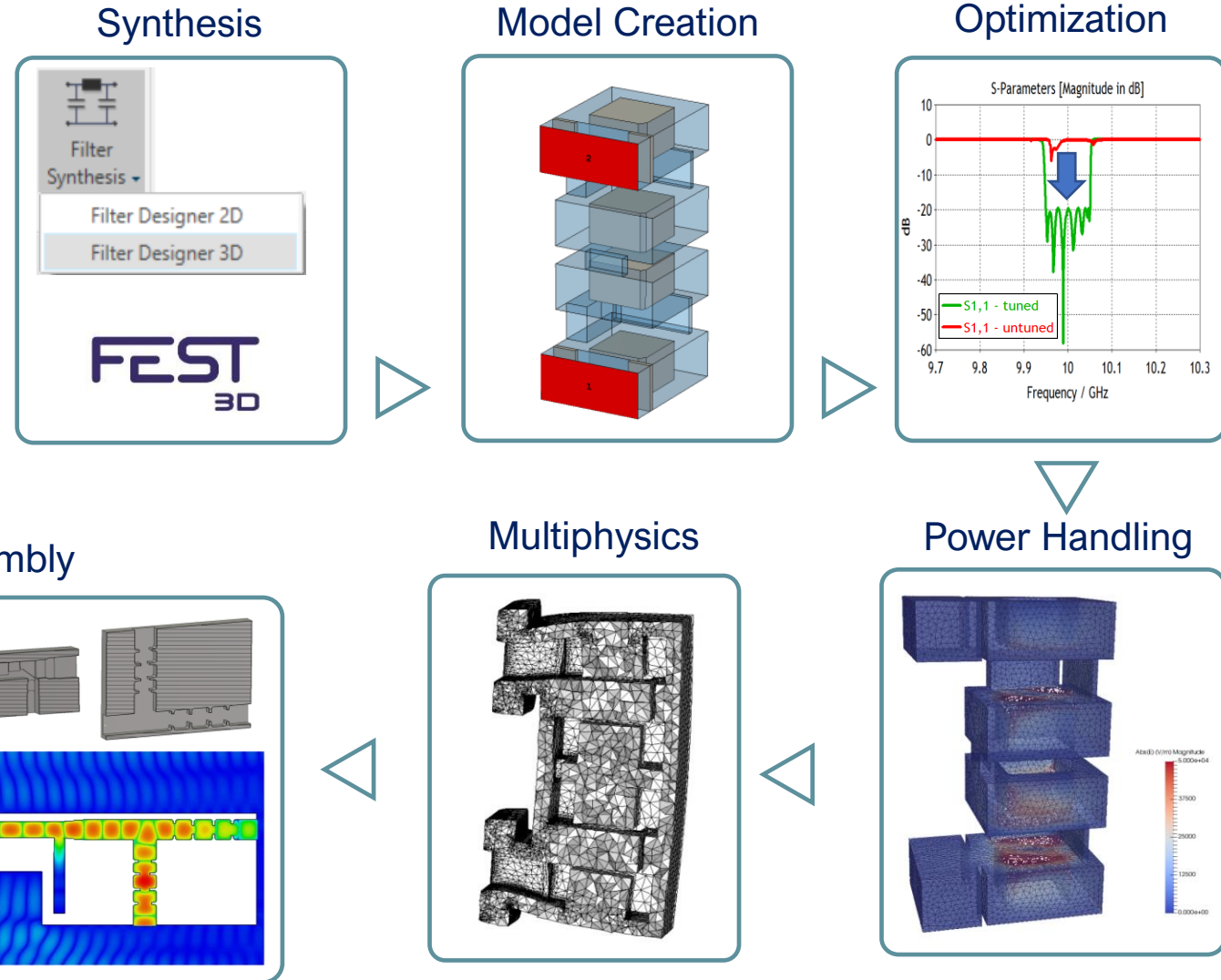
Compare set of parametric antenna prototypes and performance comparison (top)

Compliance - Human Exposure & SAR



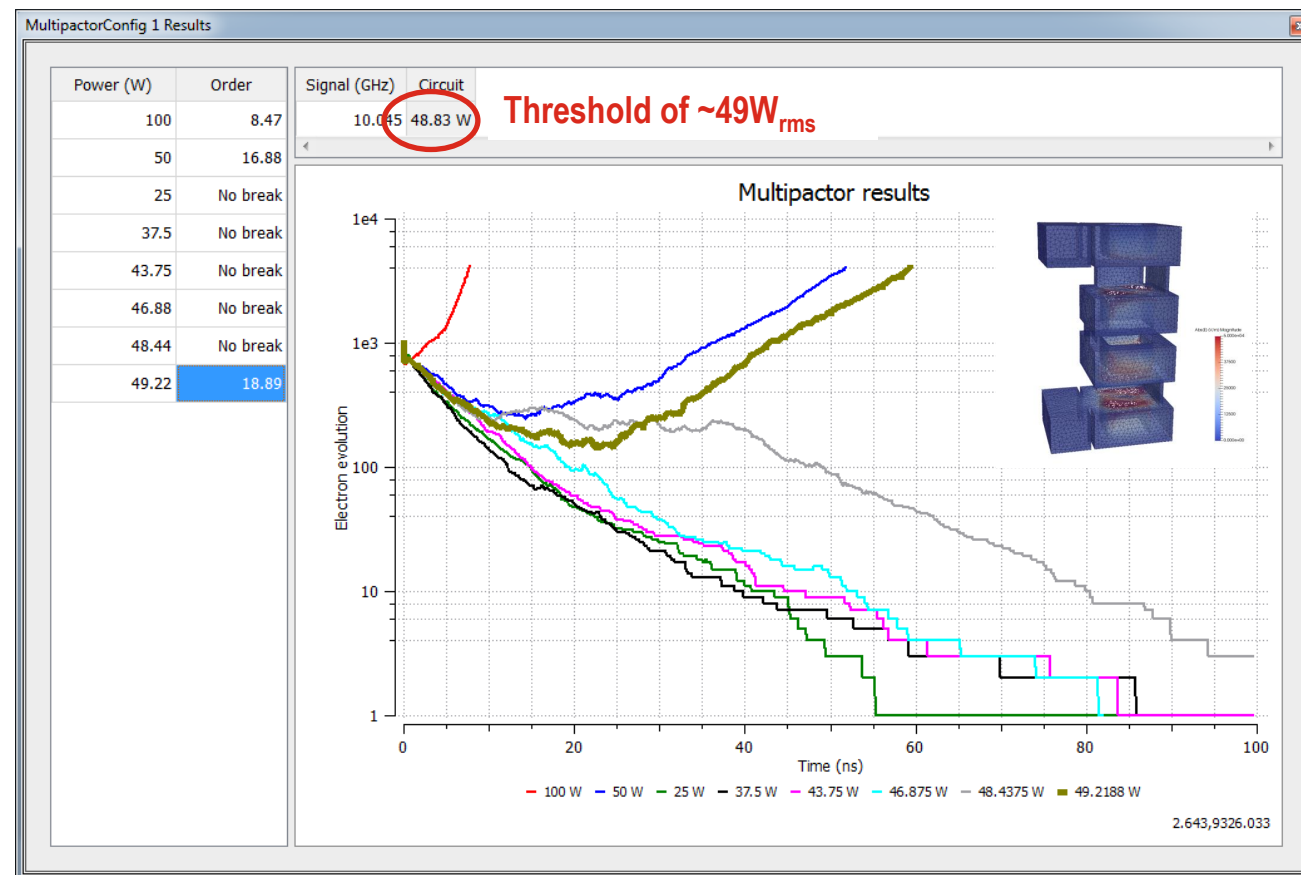
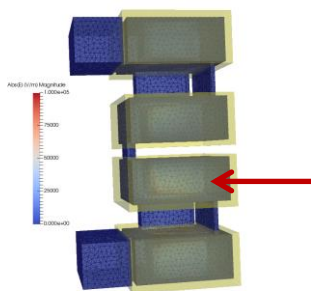
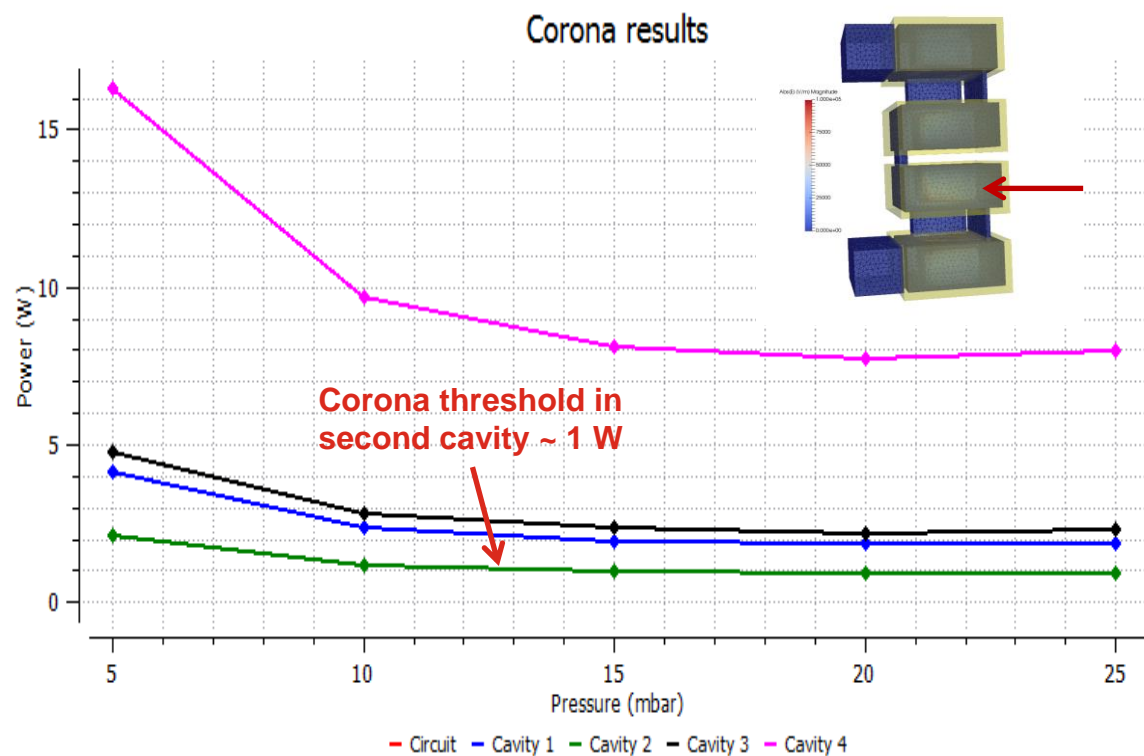
Microwave & RF Passive Components - Synthesis and Analysis

- Synthesized and design passive components based on waveguide technology.
- Synthesis tool for bandpass and diplexer filter design supporting cross coupling and advanced topologies.
- Filter optimization/tuning via coupling matrix extraction from simulated and measured scattering parameters.
- Analysis of Multipaction and Corona (arcing) for estimation of the power handling capability.
- Thermal-related, structural breakdown and cooling analysis.
- System level analysis.



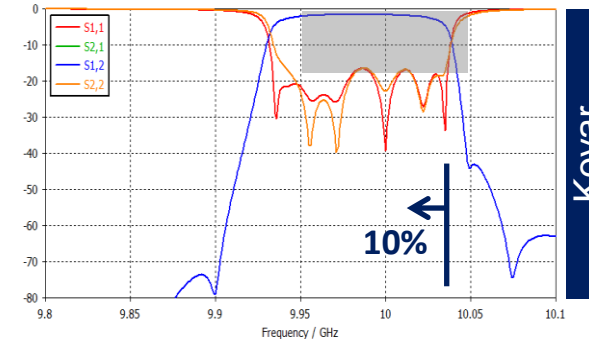
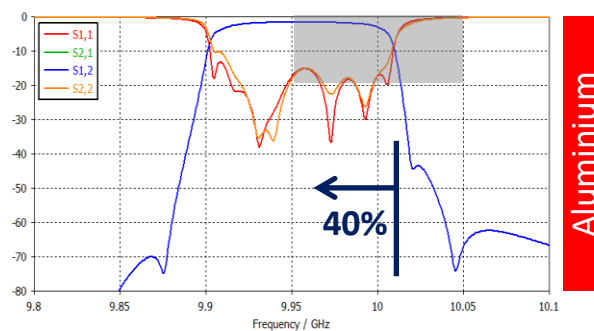
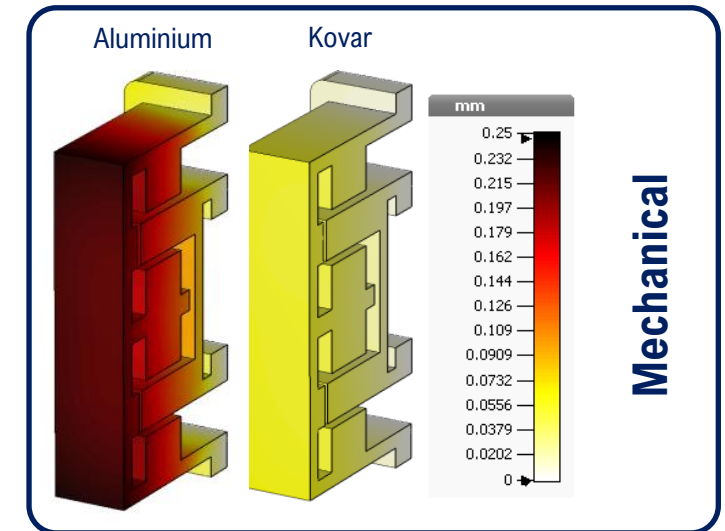
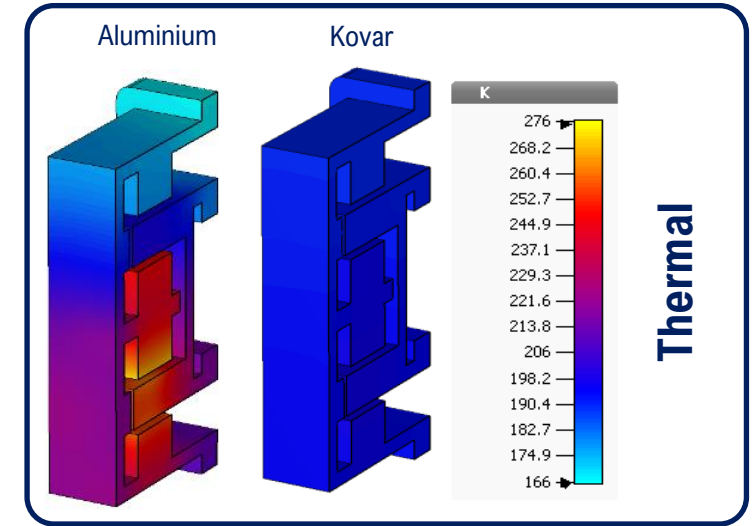
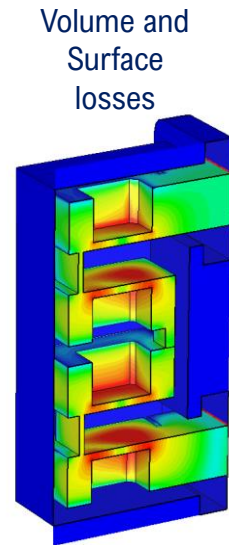
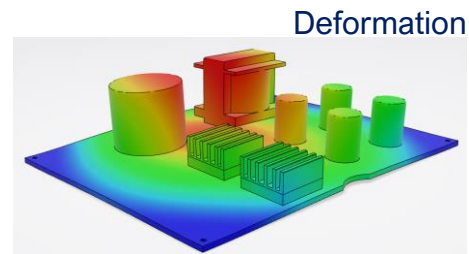
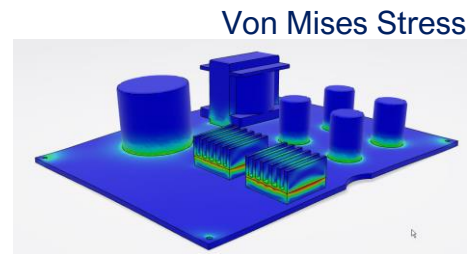
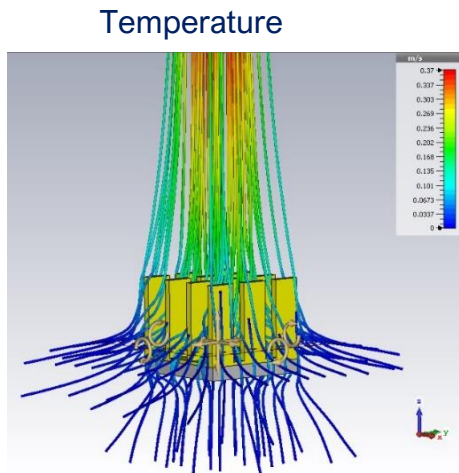
Microwave & RF Passive Components - Multipaction - Corona

- Perform Radio Frequency (RF) breakdown analysis in complicated structures.
- Furman, Vaughan and model based on imported secondary electron yield (Import) for characterization of materials.
- Multipaction analysis with single-carrier and multi-carrier simulations with arbitrary number of carriers and phase schemes.
- Possibility to add external uniform DC magnetic and/or electric field.
- Corona discharge with one or more CW signals and pulsed signals.
- Possibility of using several filling gases.



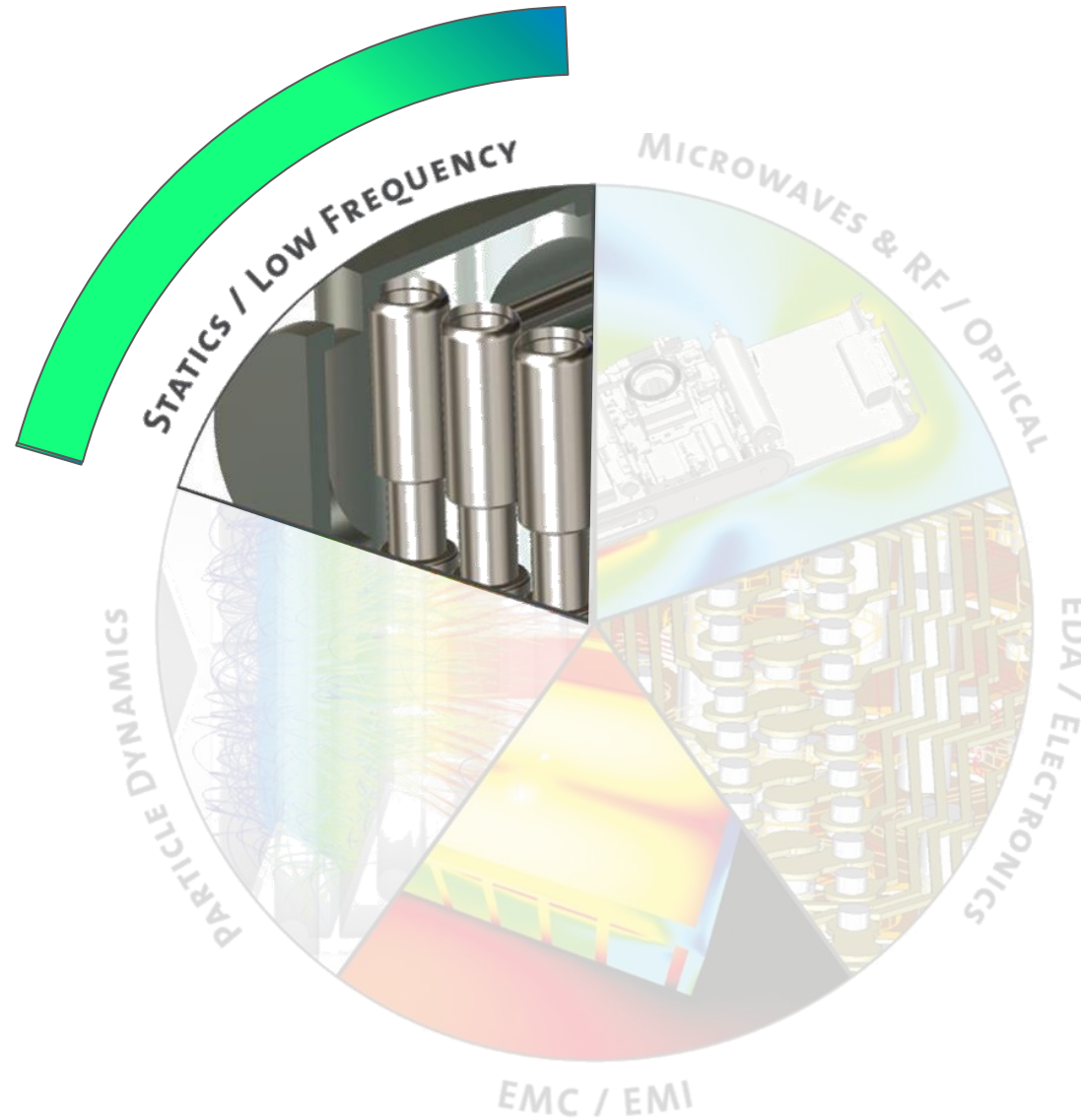
Microwave Passive Components - Multiphysics Analysis

- Perform Multiphysics analyses involving EM-Thermal-Mechanical problems.
- Steady state, transient and Conjugate Heat Transfer solvers.
- Uni-directional and Bi-directional coupling.
- Evaluate EM performance using the deformed structures from mechanical analysis and predict the detuning effect.
- Components modeling.



EM Applications

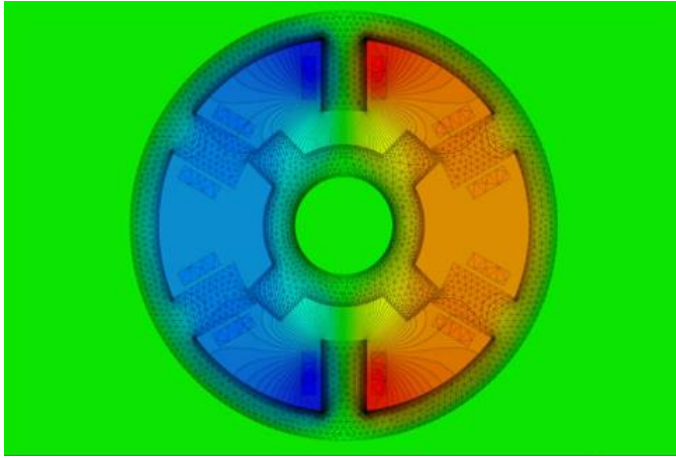
Low Frequency



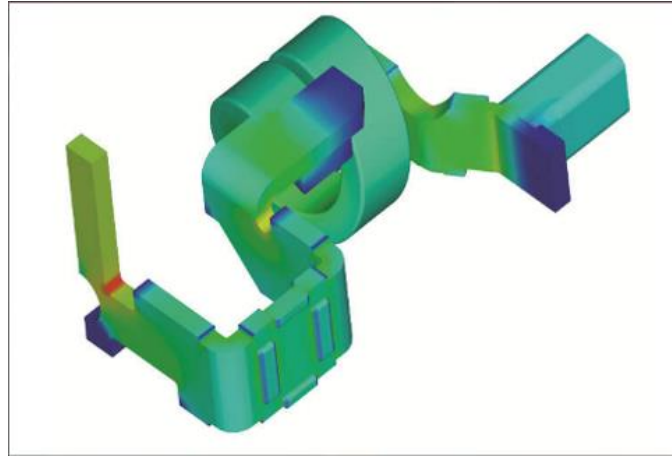
High Frequency

Statics/Low Frequency

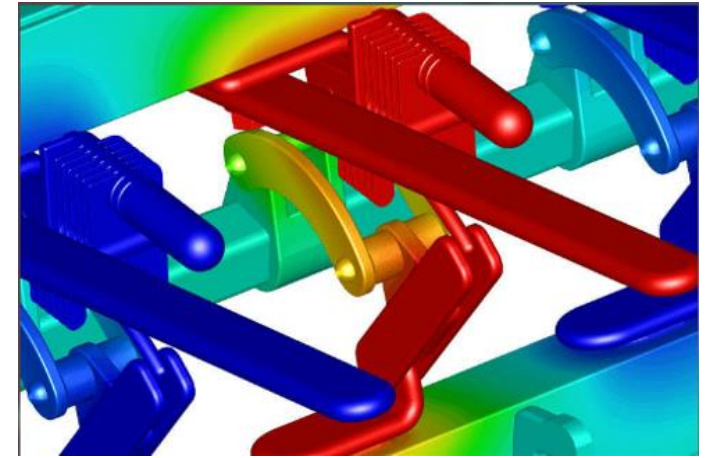
Electrical Machines



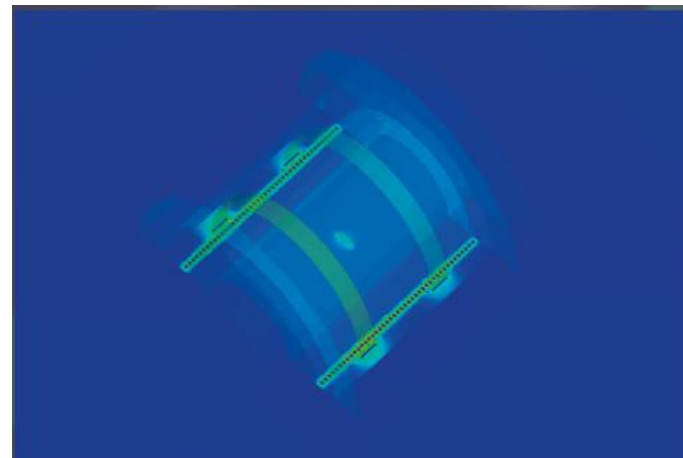
Electromechanical



Power Engineering

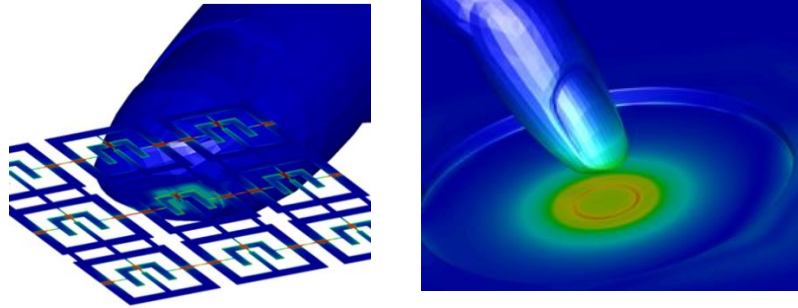


Sensors

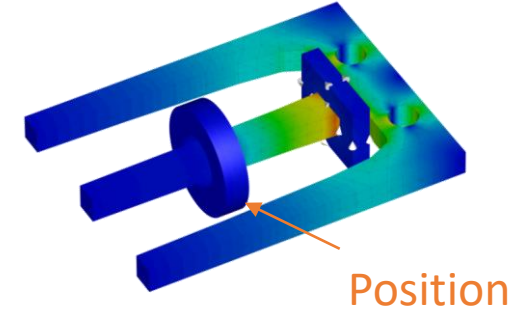
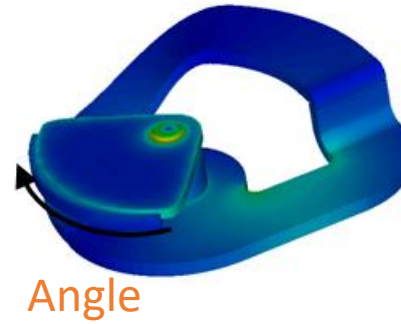


Sensors Design

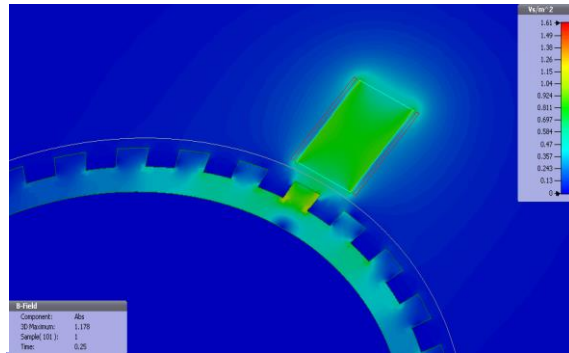
Capacitive Touchscreen



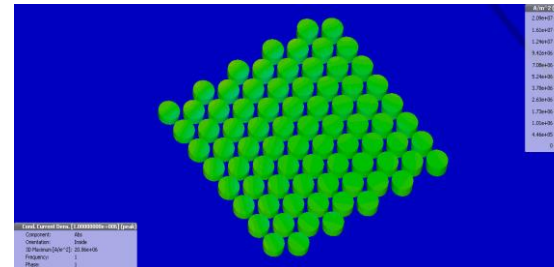
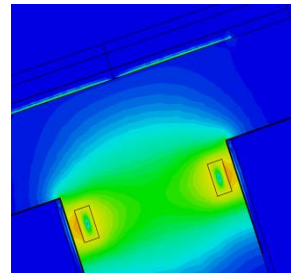
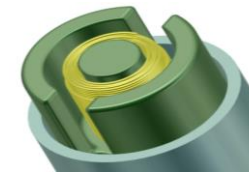
Inductive Position Sensors



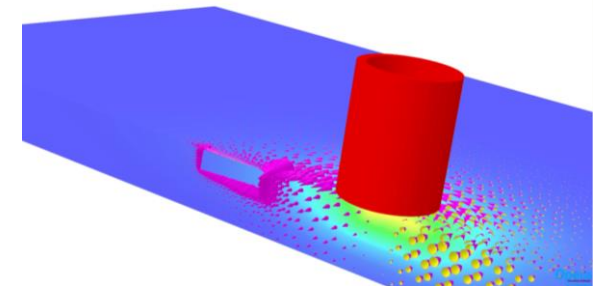
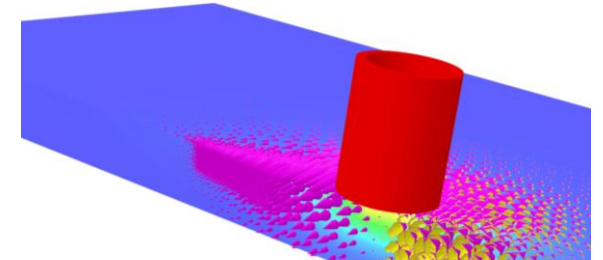
Speed Sensors



Inductive Proximity Sensors

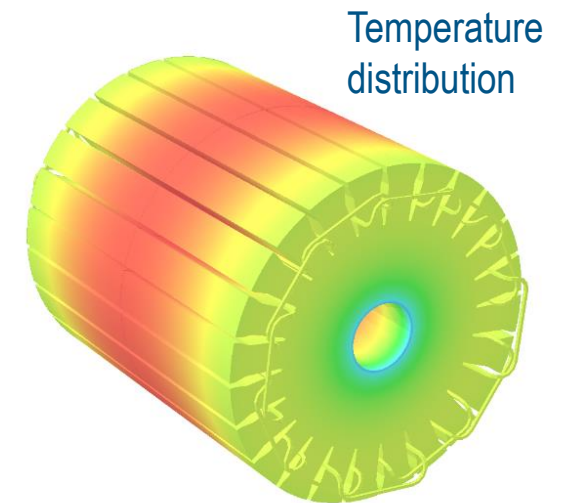
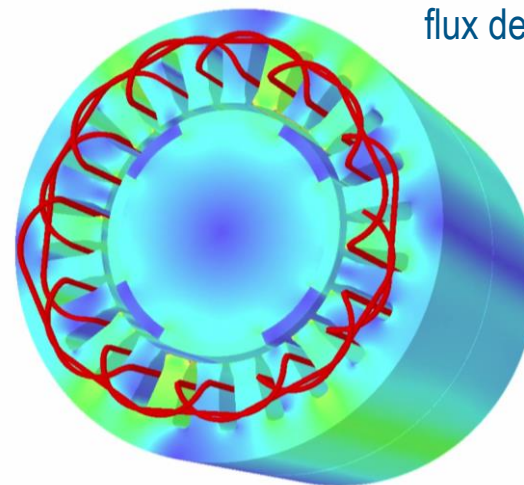
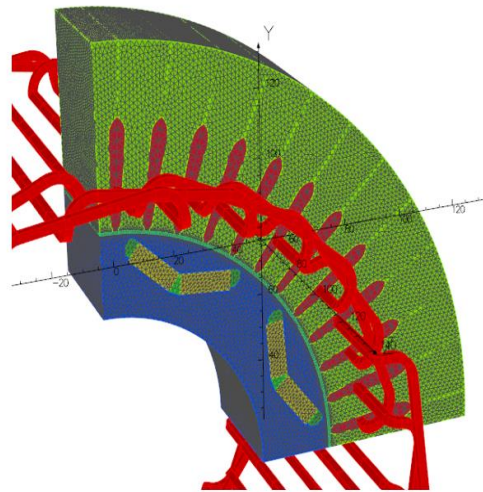
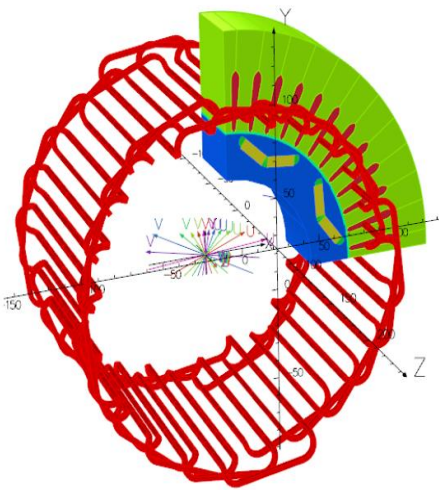
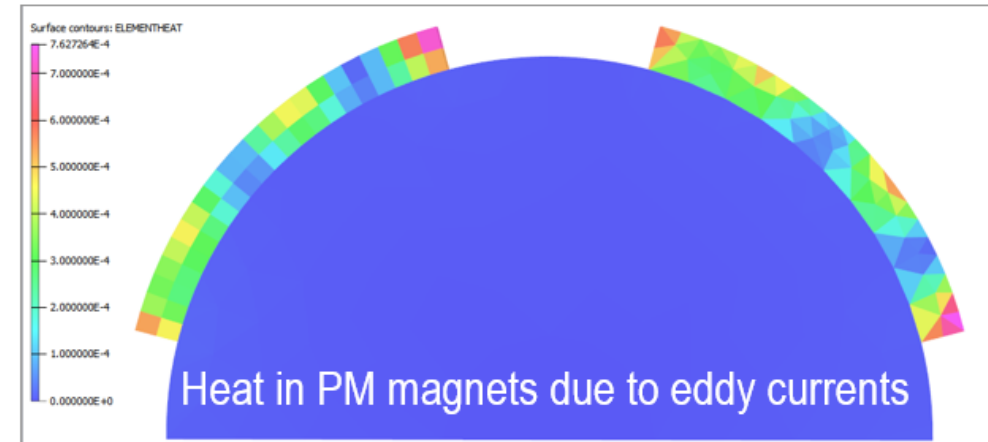


Eddy Current Non-Destructive Testing

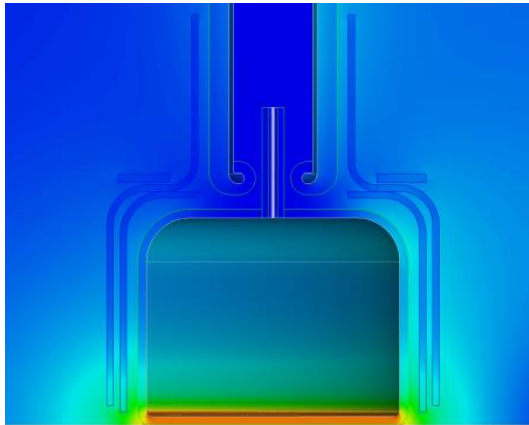
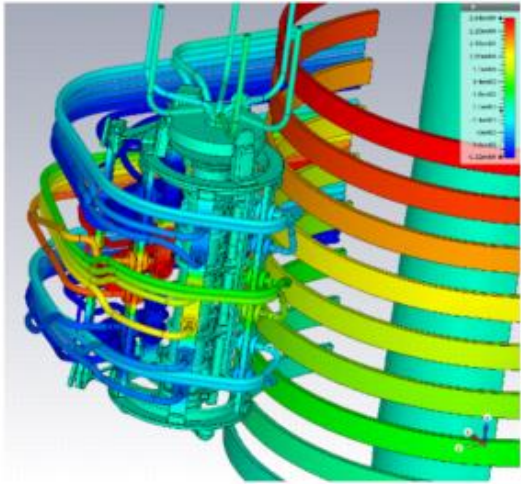


Electrical Machines: Motors & Generators

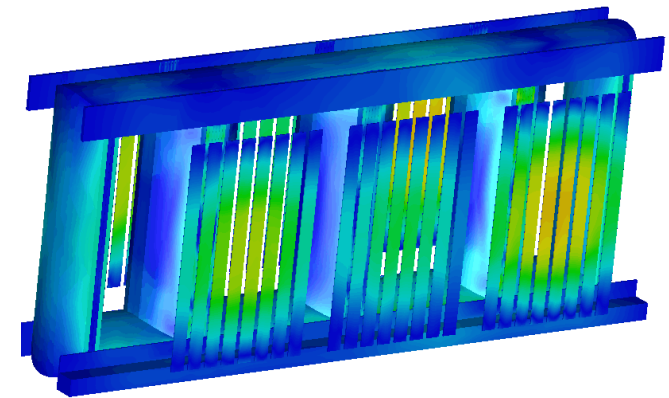
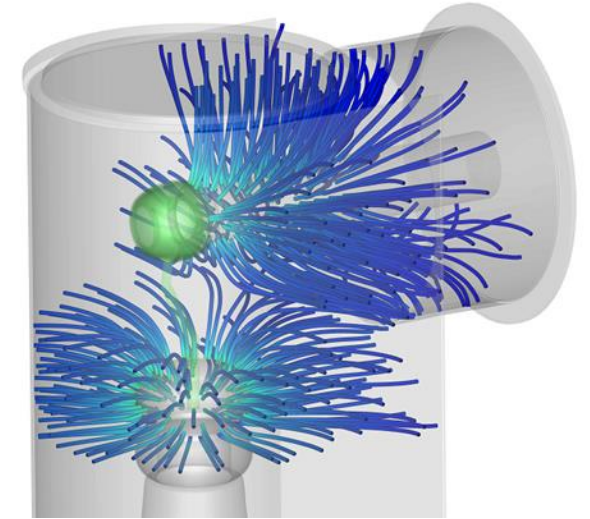
- Setup Using 'Machine Environment' and 'Winding Tool'
- Automatic Model Creation and Meshing



Power Engineering: Transformers



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- 
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Thank You

